MU181000A 12.5GHz Synthesizer MU181000B 12.5GHz 4 port Synthesizer Operation Manual

11th Edition

- For safety and warning information, please read this manual before attempting to use the equipment.
- Additional safety and warning information is provided within the MP1800A Signal Quality Analyzer Installation Guide, the MP1900A Signal Quality Analyzer-R Operation Manual, and the MT1810A 4 Slot Chassis Installation Guide. Please also refer to them before using the equipment.
- Keep this manual with the equipment.

ANRITSU CORPORATION

Document No.: M-W2750AE-11.0

Safety Symbols

To prevent the risk of personal injury or loss related to equipment malfunction, Anritsu Corporation uses the following safety symbols to indicate safety-related information. Ensure that you clearly understand the meanings of the symbols BEFORE using the equipment. Some or all of the following symbols may be used on all Anritsu equipment. In addition, there may be other labels attached to products that are not shown in the diagrams in this manual.

Symbols used in manual



DANGER

This indicates a very dangerous procedure that could result in serious injury or death if not performed properly.



WARNING

This indicates a hazardous procedure that could result in serious injury or death if not performed properly.



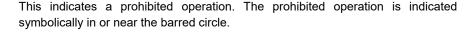
CAUTION

This indicates a hazardous procedure or danger that could result in light-to-severe injury, or loss related to equipment malfunction, if proper precautions are not taken.

Safety Symbols Used on Equipment and in Manual

The following safety symbols are used inside or on the equipment near operation locations to provide information about safety items and operation precautions. Ensure that you clearly understand the meanings of the symbols and take the necessary precautions BEFORE using the equipment.







This indicates an obligatory safety precaution. The obligatory operation is indicated symbolically in or near the circle.



This indicates a warning or caution. The contents are indicated symbolically in or near the triangle.







These indicate that the marked part should be recycled.

MU181000A 12.5GHz Synthesizer MU181000B 12.5GHz 4 port Synthesizer **Operation Manual**

27 November 2006 (First Edition) 13 February 2020 (11th Edition)

Copyright © 2006-2020, ANRITSU CORPORATION.

All rights reserved. No part of this manual may be reproduced without the prior written permission of the publisher.

The contents of this manual may be changed without prior notice.

Printed in Japan

Equipment Certificate

Anritsu Corporation certifies that this equipment was tested before shipment using calibrated measuring instruments with direct traceability to public testing organizations recognized by national research laboratories, including the National Institute of Advanced Industrial Science and Technology, and the National Institute of Information and Communications Technology, and was found to meet the published specifications.

Anritsu Warranty

Anritsu Corporation will repair this equipment free-of-charge if a malfunction occurs within one year after shipment due to a manufacturing fault. However, software fixes will be made in accordance with the separate Software End-User License Agreement. Moreover, Anritsu Corporation will deem this warranty void when:

- The fault is outside the scope of the warranty conditions separately described in the operation manual.
- The fault is due to mishandling, misuse, or unauthorized modification or repair of the equipment by the customer.
- The fault is due to severe usage clearly exceeding normal usage.
- The fault is due to improper or insufficient maintenance by the customer.
- The fault is due to natural disaster, including fire, wind, flooding, earthquake, lightning strike, or volcanic ash, etc.
- The fault is due to damage caused by acts of destruction, including civil disturbance, riot, or war, etc.
- The fault is due to explosion, accident, or breakdown of any other machinery, facility, or plant, etc.
- The fault is due to use of non-specified peripheral or applied equipment or parts, or consumables, etc.
- The fault is due to use of a non-specified power supply or in a non-specified installation location.
- The fault is due to use in unusual environments (Note).
- The fault is due to activities or ingress of living organisms, such as insects, spiders, fungus, pollen, or seeds.

In addition, this warranty is valid only for the original equipment purchaser. It is not transferable if the equipment is resold.

Anritsu Corporation shall assume no liability for injury or financial loss of the customer due to the use of or a failure to be able to use this equipment.

Note:

For the purpose of this Warranty, "unusual environments" means use:

- In places of direct sunlight
- In dusty places
- Outdoors
- In liquids, such as water, oil, or organic solvents, and medical fluids, or places where these liquids may adhere
- In salty air or in places where chemically active gases (sulfur dioxide, hydrogen sulfide, chlorine, ammonia, nitrogen dioxide, or hydrogen chloride, etc.) are present
- In places where high-intensity static electric charges or electromagnetic fields are present
- In places where abnormal power voltages (high or low) or instantaneous power failures occur
- In places where condensation occurs
- In the presence of lubricating oil mists
- In places at an altitude of more than 2,000 m
- In the presence of frequent vibration or mechanical shock, such as in cars, ships, or airplanes

Anritsu Corporation Contact

In the event of this equipment malfunctions, contact an Anritsu Service and Sales office. Contact information can be found on the last page of the printed version of this manual, and is available in a separate file on the PDF version.

Notes On Export Management

This product and its manuals may require an Export License/Approval by the Government of the product's country of origin for re-export from your country.

Before re-exporting the product or manuals, please contact us to confirm whether they are export-controlled items or not.

When you dispose of export-controlled items, the products/manuals need to be broken/shredded so as not to be unlawfully used for military purpose.

Software End-User License Agreement (EULA)

Please read this Software End-User License Agreement (hereafter this EULA) carefully before using (includes executing, copying, registering, etc.) this software (includes programs, databases, scenarios, etc., used to operate, set, etc., Anritsu electronic equipment). By reading this EULA and using this software, you are agreeing to be bound by the terms of its contents and Anritsu Corporation (hereafter Anritsu) hereby grants you the right to use this Software with the Anritsu-specified equipment (hereafter Equipment) for the purposes set out in this EULA.

1. Grant of License and Limitations

- 1. Regardless of whether this Software was purchased from or provided free-of-charge by Anritsu, you agree not to rent, lease, lend, or otherwise distribute this Software to third parties and further agree not to disassemble, recompile, reverse engineer, modify, or create derivative works of this Software.
- 2. You may make one copy of this Software for backup purposes only.
- 3. You are not permitted to reverse engineer this software.
- 4. This EULA allows you to install one copy of this Software on one piece of Equipment.

2. Disclaimers

To the extent not prohibited by law, in no event shall Anritsu be liable for personal injury, or any incidental, special, indirect or consequential damages whatsoever, including, without limitation, damages for loss of profits, loss of data, business interruption or any other commercial damages or losses, arising out of or related to your use or inability to use this Software.

3. Limitation of Liability

- a. If a fault (bug) is discovered in this Software, preventing operation as described in the operation manual or specifications whether or not the customer uses this software as described in the manual, Anritsu shall at its own discretion, fix the bug, or exchange the software, or suggest a workaround, free-of-charge. However, notwithstanding the above, the following items shall be excluded from repair and warranty.
 - If this Software is deemed to be used for purposes not described in the operation manual or specifications.
 - ii) If this Software is used in conjunction with other non-Anritsu-approved software.
 - iii) Recovery of lost or damaged data.
 - iv) If this Software or the Equipment has been modified, repaired, or otherwise altered without Anritsu's prior approval.
 - v) For any other reasons out of Anritsu's direct control and responsibility, such as but not limited to, natural disasters, software virus infections, etc.
- b. Expenses incurred for transport, hotel, daily allowance, etc., for on-site repairs by Anritsu engineers necessitated by the above faults shall be borne by you.
- c. The warranty period for faults listed in article 3a above covered by this EULA shall be either 6 months from the date of purchase of this Software or 30 days after the date of repair, whichever is longer.

4. Export Restrictions

You may not use or otherwise export or re-export directly or indirectly this Software except as authorized by Japanese and United States law. In particular, this software may not be exported or re-exported (a) into any Japanese or US embargoed countries or (b) to anyone on the Japanese or US Treasury Department's list of Specially Designated Nationals or the US Department of Commerce Denied Persons List or Entity List. By using this Software, you warrant that you are not located in any such country or on any such list. You also agree that you will not use this Software for any purposes prohibited by Japanese and US law, including, without limitation, the development, design and manufacture or production of missiles or nuclear, chemical or biological weapons of mass destruction.

5. Termination

Anritsu shall deem this EULA terminated if you violate any conditions described herein. This EULA shall also be terminated if the conditions herein cannot be continued for any good reason, such as violation of copyrights, patents, or other laws and ordinances.

6. Reparations

If Anritsu suffers any loss, financial or otherwise, due to your violation of the terms of this EULA, Anritsu shall have the right to seek proportional damages from you.

7. Responsibility after Termination

Upon termination of this EULA in accordance with item 5, you shall cease all use of this Software immediately and shall as directed by Anritsu either destroy or return this Software and any backup copies, full or partial, to Anritsu.

8. Dispute Resolution

If matters of dispute or items not covered by this EULA arise, they shall be resolved by negotiations in good faith between you and Anritsu.

9. Court of Jurisdiction

This EULA shall be interpreted in accordance with Japanese law and any disputes that cannot be resolved by negotiation described in Article 8 shall be settled by the Japanese courts.

CE Conformity Marking

Anritsu affixes the CE Conformity marking on the following product(s) in accordance with the Council Directive 768/2008/EC to indicate that they conform to the EMC, LVD and RoHS directive of the European Union (EU).

CE marking



1. Product Model

Plug-in Units:

MU181000A 12.5GHz Synthesizer MU181000B 12.5GHz 4 port Synthesizer

2. Applied Directive and Standards

When the MU181000A 12.5GHz Synthesizer or MU181000B 12.5GHz 4 port Synthesizer is installed in the MP1800A, MT1810A or MP1900A the applied directive and standards of this unit conform to those of the MP1800A, MT1810A or MP1900A main frame.

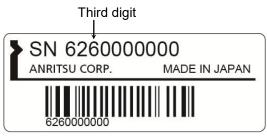
PS: About main frame

Please contact Anritsu for the latest information on the main frame types that MU181000A/B can be used with.

If the third digit of the serial number is "7", the product complies with Directive 2011/65/EU as amended by (EU) 2015/863.

(Pb,Cd,Cr6+,Hg,PBB,PBDE,DEHP,BBP,DBP,DIBP) If the third digit of the serial number is "6", the product complies with Directive 2011/65/EU.

(Pb,Cd,Cr6+,Hg,PBB,PBDE)



Serial number example

RCM Conformity Marking

Anritsu affixes the RCM mark on the following product(s) in accordance with the regulation to indicate that they conform to the EMC framework of Australia/New Zealand.

RCM marking



1. Product Model

Plug-in Units: MU181000A 12.5GHz Synthesizer

MU181000B 12.5GHz 4 port Synthesizer

2. Applied Directive and Standards

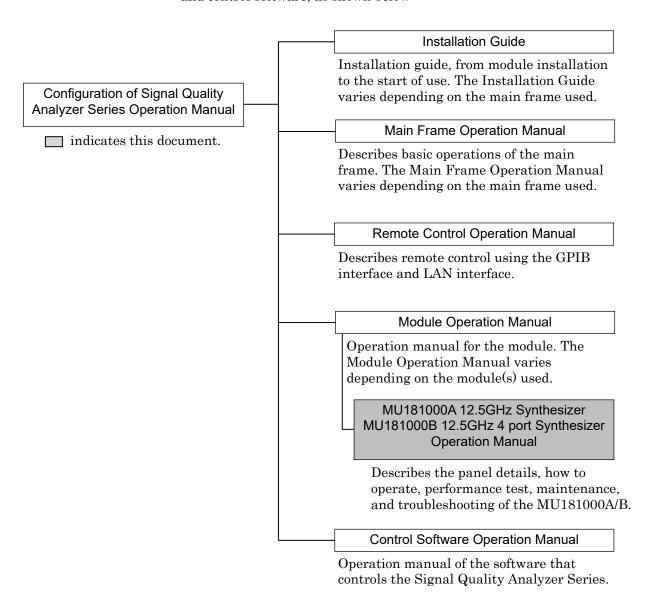
When the MU181000A 12.5GHz Synthesizer or MU181000B 12.5GHz 4 port Synthesizer is installed in the MP1800A, MT1810A or MP1900A the applied directive and standards of this unit conform to those of the MP1800A, MT1810A or MP1900A main frame.

PS: About main frame

Please contact Anritsu for the latest information on the main frame types that MU181000A/B can be used with.

About This Manual

A testing system combining an MP1800A Signal Quality Analyzer or MT1810A 4 Slot Chassis mainframe, module(s), and control software is called a Signal Quality Analyzer Series. The operation manuals of the Signal Quality Analyzer Series consist of separate documents for the installation guide, the mainframe, remote control operation, module(s), and control software, as shown below



A test system combining an MP1900A Signal Quality Analyzer-R, module(s), and control software is called a Signal Quality Analyzer-R Series. The operation manuals of the Signal Quality Analyzer-R Series consist of separate documents for the MP1900A, module(s), and control software as shown below.

Configuration of Signal Quality Analyzer-R Series Operation

indicates this document.

MP1900A Signal Quality Analyzer-R Operation Manual

Describes the basic operations, panel details, and maintenance of the MP1900A, as well as the steps from module installation to the start of use.

Module Operation Manual

MU195020A 21G/32G bit/s SI PPG MU195040A 21G/32G bit/s SI ED MU195050A Noise Generator Operation Manual

Describes the panel details, how to operate, performance test, maintenance, and troubleshooting of the module to be installed on the MP1900A.

MU196020A PAM4 PPG MU196040A PAM4 ED MU196040B PAM4 ED Operation Manual

Describes the panel details, performance test, maintenance, and troubleshooting of the MU196020A, MU196040A, and MU196040B.

MU181000A 12.5GHz Synthesizer MU181000B 12.5GHz 4 port Synthesizer Operation Manual

Describes the panel details, how to operate, performance test, maintenance, and troubleshooting of the MU181000A and MU181000B.

MU181500B Jitter Modulation Source Operation Manual

Describes the panel details, how to operate, performance test and maintenance of the MU181500B.

MU183020A 28G/32G bit/s PPG MU183021A 28G/32G bit/s 4ch PPG Operation Manual

Describes the panel details, performance test, maintenance, and troubleshooting of the MU183020A and MU183021A.

MU183040A 28G/32G bit/s ED MU183041A 28G/32G bit/s 4ch ED MU183040B 28G/32G bit/s High Sensitivity ED MU183041B 28G/32G bit/s 4ch High Sensitivity ED Operation Manual

Describes the panel details, how to operate, performance test, maintenance, and troubleshooting of the MU183040A, MU183041A, MU183040B, and MU183041B.

Configuration	on of Signal Quality Analyzer-R Series Operation (Cont'd) indicates this document.
	MX190000A Signal Quality Analyzer-R Control Software Operation Manual
	Describes the operation of the software that controls the Signal Quality Analyzer-R
	Series.
	Extended Application Operation Manual
	Describes the operation of the extended application for the Signal Quality Analyzer-R Series.
	MX183000A High-Speed Serial Data Test Software Operation Manual
	Describes the setup and operating procedure of MX183000A.

Table of Contents

About	Inis Manual	. 1
Chapte	er 1 Overview	1-1
1.1		
1.2		
1.3	3	
Chapte	er 2 Preparation before Use	2-1
2.1	Installation to Signal Quality Analyzer	2-2
2.2	How to Operate Application	2-2
2.3	Preventing Damage	2-3
Chapt	er 3 Panel Layout and Connectors	3-1
- 3.1	Panel Layout	3-2
3.2	Inter-Module Connection	3-6
Chapte	er 4 Configuration of Setup Dialog E	3ox 4-1
4.1		
4.2		
Chapt	er 5 Use Example	5-1
5.1	MU181000A/B Usage Example	5-2
Chapte	er 6 Performance Test	6-1
6.1		
6.2		
6.3	·	

Chapte	r 7 Maintenance7-1			
7.1	Daily Maintenance7-2			
7.2	Cautions on Storage7-2			
7.3	Transportation7-3			
7.4	Calibration7-3			
7.5	Disposal7-4			
Chapte	r 8 Troubleshooting8-1			
8.1	Problems Discovered during Module Replacement 8-2			
8.2	Problems Discovered during Use of MU181000A/B 8-2			
Appendi	x A Performance Test Result Sheet A-1			
Append	lix B List of Initial Setting Items B-1			
Appendix C List of Setting Items in				
- - - - - - - - -	•			
	Customize Screen C-1			

1
2
3
4
5
6
7

8

Appendix

Chapter 1 Overview

This section provides an overview and the specifications of the MU181000A 12.5GHz Synthesizer and the MU181000B 12.5GHz 4 port Synthesizer (hereinafter referred to as MU181000A/B).

1.1	Product Overview1-		
1.2	Produ	ct Configuration	1-3
	1.2.1	Standard Configuration	1-3
	1.2.2	Option	1-4
	1.2.3	Application parts	1-5
1.3	Specifications		

1.1 Product Overview

The MU181000A/B is a plug-in module that can be built into the models of Signal Quality Analyzer Series or Signal Quality Analyzer-R Series. It outputs clock signals of 100 MHz to 12.5 GHz to be input to the MU181020A 12.5 Gbit/s PPG or the MU181800A 12.5 GHz Clock Distributor.

The MU181000A/B outputs a 10 MHz reference signal to synchronize an external device with it. The MU181000A/B can also be synchronized with an external device by inputting a 10 MHz reference signal output from that device.

Also, when MU181000B-x02 is installed, test signals synchronized with 100 MHz reference clock from PCI Express Host can be output. (MU181000B-x02 is usable only when MU181000B is installed in MP1900A.)

1.2 Product Configuration

1.2.1 Standard Configuration

Table 1.2.1-1 and Table 1.2.1-2 show the standard configuration of the MU181000A/B.

Table 1.2.1-1 Standard Configuration of MU181000A

Item	Model name/symbol	Product name	Q'ty	Remarks
Main unit	MU181000A	12.5GHz Synthesizer	1	
Accessory	J1624A	Coaxial cable, 0.3 m	1	SMA connector
	Z0897A	Operation Manual*	1	CD-ROM version
	Z0918A	MX180000A Software CD*	1	CD-ROM version

^{*:} Not supplied when the MU181000A is installed on the MP1900A.

Table 1.2.1-2 Standard Configuration of MU181000B

Item	Model name/symbol	Product name	Q'ty	Remarks
Main unit	MU181000B	12.5 GHz 4 port Synthesizer	1	
Accessory	J1624A	Coaxial cable, 0.3 m	4	SMA connector
	Z0897A	Operation Manual*	1	CD-ROM version
	Z0918A	MX180000A Software CD*	1	CD-ROM version

^{*:} Not supplied when the MU181000B is installed on the MP1900A.

1.2.2 Option

Table 1.2.2-1 and 1.2.2-2 show the options for the MU181000A/B. All options are sold separately.

Table 1.2.2-1 Options for MU181000A

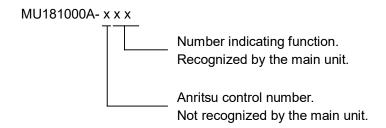
Model name/symbol	bol Product name		Remarks
MU181000A-x01	Jitter Modulation	1	

Table 1.2.2-2 Options for MU181000B

Model name/symbol Product name		Q'ty	Remarks
MU181000B-x01 Jitter Modulation		1	
MU181000B-x02	J181000B-x02 SSC Extension		

Notes:

• Option name format



• MU181000B-x02 is usable only when it is installed in MP1900A. If installed in MP1800A, the MP1800A shows no presence of this option on the screen and operates without it.

1.2.3 Application parts

Table 1.2.3-1 shows the application parts for the MU181000A/B. All application parts are sold separately.

Table 1.2.3-1 Application parts for MU181000A/B

Model name/symbol	Product	Q'ty	Remarks
J1625A	Coaxial cable, 1 m	1	SMA connector
J0127B	Coaxial cable, 2 m	1	SMA connector
J1137	Terminator	1	$50 \Omega \text{ SMA}$
W2750AE	Operation Manual	1	Printed version

1.3 Specifications

Table 1.3-1 Specifications

ltem		Specifications	
Electrical	Frequency range	0.1 to 12.5 GHz	
performance	Setting resolution	1 kHz, 1 MHz switchable	
Clock Output		Offset function: -1000 to +1000 ppm	
		Resolution: 1 ppm steps, 1 Hz minimum	
	Frequency stability	±1 ppm	
		When Reference Clock Source is set to Internal	
	Output level	MU181000A: 0.632 to 2 Vp-p (AC)	
		MU181000B, MU181000A/B-x01: 0.4 to 1 Vp-p (AC)	
	Phase noise	≤–61 dBc/Hz at 1 kHz offset	
		≤–80 dBc/Hz at 10 kHz offset	
		≤–90 dBc/Hz at 100 kHz offset	
	Residual wander	MU181000A/B: ≤20 ps (p-p)	
		MU181000A/B-x01:	
		When Fc >400 MHz: ≤20 ps (p-p)	
		When Fc ≤400 MHz: ≤0.02/Fc (Hz) ×10^12 ps (p-p)	
		Measurement conditions: Overwrite for 10 s using Buff Output (when Internal is selected) as trigger signal of sampling oscilloscope.	
		Measurement points: 100 MHz/150 MHz/600 MHz/1.25 GHz/2.5 GHz/10 GHz/12.5 GHz	
	Duty	$50 \pm 10\%$	
	Output wavelength	<1 GHz Rectangular wave	
		≥1 GHz Sine wave or rectangular wave	
		Definition of rectangular wave lower than 1 GHz:	
		$\leq 350 \text{ ps at tr, tf} = 20 \text{ to } 80\%$	
	Clock output	≤10 ps (12.5 GHz)	
	Channel skew	Applied to the MU181000B and MU181000B-x01.	
	Output impedance	50 Ω/GND	
	Connector	SMA	

Table 1.3-1 Specifications (Cont'd)

Item		Specifications		
10 MHz reference	Frequency	10 MHz±10 ppm		
signal	Level	0.5 to 2.0 Vp-p (AC)		
Ref. Input	Impedance	50 Ω/GND		
	Waveform	Sine wave or rectangular wave		
	Duty	$50 \pm 10\%$		
	Connector	BNC		
Buff Output	Frequency stability	Internal: 10 MHz±1 ppm		
		External: Depends on reference input to Ref. Input		
	Level	1.0 Vp-p±30% (AC)		
	Impedance	50 Ω/GND		
	Waveform	Rectangular wave		
	Duty	50±10%		
	Connector	BNC		
Trigger Output	Effective range	800 MHz < Fc ≤ 12.5 GHz Fc: Clock output frequency		
When MU181000A/B-x01	Output frequency	When $6.4~\mathrm{GHz} < \mathrm{Fc} \le 12.5~\mathrm{GHz}$: 1 or 64 division selectable		
is installed		When 800 MHz < Fc ≤ 6.4 GHz: Fixed to 64 divisions		
	Output level	0.4 to 1.1 Vp-p (AC)		
	Output impedance	50 Ω/GND		
	Connector	SMA		
External modulation input	Refer to 2.2 "How to functions and perform	Operate Application" and 2.3 "Preventing Damage" for mance.		
(Jitter Ext Input)	Frequency range	9 Hz to 1 GHz		
When MU181000A/B-x01	Input waveform	Sine wave		
is installed	Input level range	3 Vp-p max, 0 Vdc max.		
15 III5taiica	Input impedance	50 Ω/GND		
	Connector	SMA		

Table 1.3-1 Specifications (Cont'd)

Item		Specification	ons	
External I,Q	Frequency band	DC to 320 MHz max. (–3 dB)		
When MU181000A/B-x01		Note that the maximum band is li set bit rate.	imited, depending on the	
is installed		$2.4 \text{ GHz} < \text{Fc} \le 12.5 \text{ GHz}$:	$320~\mathrm{MHz}$	
		$1.4 \text{ GHz} < \text{Fc} \le 2.4 \text{ GHz}$:	$100~\mathrm{MHz}$	
		$0.65 \text{ GHz} < \text{Fc} \le 1.4 \text{ GHz}$:	$20~\mathrm{MHz}$	
		$0.4 \text{ GHz} < \text{Fc} \le 0.65 \text{ GHz}$:	$10~\mathrm{MHz}$	
		$0.1 \text{ GHz} \leq \text{Fc} \leq 0.4 \text{ GHz}$:	$5~\mathrm{MHz}$	
	Input level range	±0.5 V		
	Input impedance	50 Ω/GND		
	Connector	BNC		
signal input (100 MHz Ref Input) When MU181000A/B-x01 or x02 is installed				
	Input signal	Carrier frequency:	100 MHz	
		Modulation frequency:	30 to 33 kHz	
		Frequency deviation amount:	500 kHz p-p max.	
	Level	1 Vp-p ± 30% (AC) When MU181000B-x01 is ins 0.15 to 1.3 Vp-p (AC) When MU181000B-x02 or MU is installed		
	Waveform	Sine wave or rectangular wave		
	Duty	50±10%		
	Input impedance	50 Ω/GND		
	Connector	BNC		

Table 1.3-1 Specifications (Cont'd)

Item				Specificat	ions	
Modulation function (Internal Jitter) When MU181000A/B-x01 is installed	Jitter mask	Jitter Amplitude (Ulp-p)	0.22		Slope: –20 Fm uency (Hz)	
		Fc r	ange (GHz)		Fm2 (Hz)	Fm3 (Hz)
			$< Fc \le 12.5$		4 M	80 M
			< Fc ≤ 6.4	110	2 M	40 M
			< Fc ≤ 3.2	55	1 M	20 M
		0.8	< Fc ≤ 1.6	27.5	500 k	10 M
		0.1	$\leq Fc \leq 0.8$	13.75	250 k	5 M

Table 1.3-1 Specifications (Cont'd)

Ite	ltem		Specifications		
Modulation	Modulation	$6.4 \text{ GHz} < \text{Fc} \le 12.5 \text{ GHz}$:	9 Hz to 80 MHz		
function	frequency range	$3.2 \text{ GHz} < \text{Fc} \le 6.4 \text{ GHz}$:	9 Hz to 40 MHz		
(Internal Jitter)		$1.6 \text{ GHz} < \text{Fc} \le 3.2 \text{ GHz}$:	9 Hz to 20 MHz		
(Cont'd)		$0.8 \mathrm{GHz} < \mathrm{Fc} \le 1.6 \mathrm{GHz}$:	9 Hz to 10 MHz		
When		$0.1 \text{ GHz} \le \text{Fc} \le 0.8 \text{ GHz}$:	9 Hz to 5 MHz		
MU181000A/B-x01 is installed	Modulation	9 Hz ≤ Fm ≤ 10 Hz:	0.001 Hz steps		
is instance	frequency setting	10 Hz < Fm ≤ 100 Hz:	0.01 Hz steps		
	resolution	100 Hz < Fm ≤ 1 kHz:	0.1 Hz steps		
		1 kHz < Fm ≤ 10 kHz:	1 Hz steps		
		10 kHz < Fm ≤ 100 kHz:	10 Hz steps		
		100 kHz < Fm ≤ 1 MHz:	100 Hz steps		
		1 MHz < Fm ≤ 10 MHz:	1 kHz steps		
		10 MHz < Fm ≤ 80 MHz:	10 kHz steps		
	Modulation	±100 ppm			
	frequency accuracy				
	Jitter amplitude	0.000 to 0.999 UIp-p:	0.001 UI steps		
	Setting resolution	1.00 to 32.00 UIp-p:	0.01 UI steps		
		32.1 to 256.0 UIp-p:	0.1 UI steps		
		257 to 2049 UIp-p:	1 UI steps		
		2050 to 4000 UIp-p:	10 UI steps		
	Jitter amplitude	Fc < 1 GHz			
	accuracy	0.001 to 2.19 UIp-p:	±0.01 UI±Q%		
		2.2 to 21.99 UIp-p:	±0.2 UI±Q%		
		22 to 4000 UIp-p:	±2 UI±Q%		
		$Fc \ge 1 \text{ GHz}$			
		0.001 to 2.19 UIp-p:	±0.02 UI±Q%		
		2.2 to 21.99 UIp-p:	±0.2 UI±Q%		
		22 to 4000 UIp-p:	±2 UI±Q%		
		Fm (Hz)	Q		
		9 ≤ Fm ≤ 500 k	7		
		500 k < Fm ≤ 2 M	12		
		$2 \text{ M} < \text{Fm} \le 80 \text{ M}$	15		

Table 1.3-1 Specifications (Cont'd)

ltem		Spe	cifications		
External Jitter 1	Modulation	When Operation is Variab	ole;		
When	frequency range	$4.0 \text{ GHz} \leq \text{Fc} \leq 12.5 \text{ GHz}$:		Hz to 1 GHz	
MU181000A/B-x01		2.4 GHz < Fc < 4.0 GHz:	9]	Hz to 500 MHz	
is installed		$1.4 \text{ GHz} < \text{Fc} \le 2.4 \text{ GHz}$:	9]	Hz to 100 MHz	
		$0.65 \text{ GHz} < \text{Fc} \le 1.4 \text{ GHz}$:	9]	Hz to 20 MHz	
		$0.4 \text{ GHz} < \text{Fc} \le 0.65 \text{ GHz}$:	9]	Hz to 10 MHz	
		$0.1 \text{ GHz} \leq \text{Fc} \leq 0.4 \text{ GHz}$:	9]	Hz to 5 MHz	
	Input waveform	Sine wave			
	FM frequency range	275 Hz/550 Hz/1 kHz/1.1 k 5.5 kHz/11 kHz/22 kHz/27 100 kHz/110 kHz/220 kHz 1 MHz/2 MHz/4 MHz/80 M Full Range is supported w Input Freq. is 4 MHz or m	7.5 kHz/44 kl 3/250 kHz/44 MHz/500 MH 3 ^r hen UI Ran	Hz/55 kHz/ 0 kHz/500 kHz/ [z/1 GHz/Full	
	Jitter amplitude	0.22 UI/2.0 UI/20 UI/200 U	UI/4000 UI		
	range Modulation	For 0.22 UI Range			
	sensitivity	When input level is 0.5 Vp-p:			
			P P		
		FM Frequency Input	Frequency	Jitter Amplitude	
		4 MHz 9 Hz 80 MHz 4 M t 500 MHz*1 80 M t	to 4 MHz to 80 MHz to 500 MHz Hz to 1 GHz	0.1 UIp-p±0.03 UI	
		*1: 500 MH- Dongs is not	المائلسسا	0.1 CZE221 4 CH-	
		*1: 500 MHz Range is not ap			
		The upper limit module			
		The upper mint modula	ation freque	ncy is noted above.	
		When the input level at 0. amplitude is UIx:	1 UIp-p is V	in, and jitter	
		Relationship between Vir	n and UIx is	approximated as	
		Unit of Vin is Vp-p while	UIp-p for U	$II_{\mathbf{X}}$	
		When $UIx \le 0.1 UIp-p$:			
		$UIx = 0.2 \times Vin$			
		Vin = Uix / 0.2			
		When $0.1 \text{ UIp-p} < \text{UIx} \le$			
		$UIx = 0.2 \times Vin \times (1 - 1)$			
		Vin = 2.5 - root (6.25)	$-22.73 \times U$	(x)	

Table 1.3-1 Specifications (Cont'd)

			Specifica	•	<u> </u>	
Item		Specifications				
External Jitter 1	Modulation	For 2 UI/20 UI/200 UI/4000 UI Range				
(Cont'd)	sensitivity	7	When input le	evel is $0.5~\mathrm{Vp}$	-p:	
When	(Cont'd)	С	lock output frequ	ency: 6.4 GHz <	- Fc ≤ 12.5 GHz	
MU181000A/B-x01 is installed			Jitter Amplitude Range	FM Frequency Range	Input Frequency	Jitter Amplitude
			2 UI	4 MHz	440 kHz	1 UIp-p±0.3 UI
			20 UI	440 kHz	44 kHz	10 UIp-p±3 UI
			200 UI	44 kHz	$4.4~\mathrm{kHz}$	100 UIp-p±30 UI
			4000 UI	$4.4~\mathrm{kHz}$	$220~\mathrm{Hz}$	1000 UIp-p±300 UI
		С	lock output freque	ency: 3.2 GHz <	Fc ≤ 6.4 GHz	
			Jitter Amplitude Range	FM Frequency Range	Input Frequency	Jitter Amplitude
			2 UI	2 MHz	$220~\mathrm{kHz}$	1 UIp-p±0.3 UI
			20 UI	$220~\mathrm{kHz}$	$22~\mathrm{kHz}$	10 UIp-p±3 UI
			200 UI	22 kHz	2.2 kHz	100 UIp-p±30 UI
			4000 UI	$2.2~\mathrm{kHz}$	110 Hz	1000 UIp-p±300 UI
		C	Clock output frequ	iency: 1.6 GHz <	$Fc \leq 3.2 \; GHz$	
			Jitter Amplitude Range	FM Frequency Range	Input Frequency	Jitter Amplitude
			2 UI	1 MHz	110 kHz	1 UIp-p±0.3 UI
			20 UI	110 kHz	11 kHz	10 UIp-p±3 UI
			200 UI	11 kHz	1.1 kHz	100 UIp-p±30 UI
			4000 UI	$1.1~\mathrm{kHz}$	55 Hz	1000 UIp-p±300 UI
		(Clock output frequ	-	Fc ≤ 1.6 GHz	
			Jitter Amplitude Range	FM Frequency Range	Input Frequency	Jitter Amplitude
			2 UI	500 kHz	55 kHz	1 UIp-p±0.3 UI
			20 UI	55 kHz	5.5 kHz	10 UIp-p±3 UI
			200 UI 4000 UI	5.5 kHz 550 Hz	550 Hz 27.5 Hz	100 UIp-p±30 UI 1000 UIp-p±300 UI
			Clock output frequ		•	1000 C1p p±300 C1
			Jitter	FM	1 0 3 0.0 0112	
			Amplitude Range	Frequency Range	Input Frequency	Jitter Amplitude
			2 UI	250 kHz	27.5 kHz	1 UIp-p±0.3 UI
			20 UI	27.5 kHz	2.75 kHz	10 UIp-p±3 UI
			200 UI	2.75 kHz	275 Hz	100 UIp-p±30 UI
			4000 UI	275 Hz	13.75 Hz	1000 UIp-p±300 UI
			ter amplitude	_	,	
		2 U	JI Range:		[p-p (0.11 to 1	
		20	UI Range:	2 to 20 UIp	-p (0.1 to 1 V	р-р)
		200) UI Range:	20 to 200 U	Tp-p (0.1 to 1	Vp-p)
			00 UI Range:		UIp-p (0.1 to	= =
		400	o or mange.	200 10 4000	, στη η (σ.τ μ	л 4 ү р р/

Table 1.3-1 Specifications (Cont'd)

Item		Specifications			
External Jitter 1	Jitter Mask	When FM Freq.Rai	nge is 500 MHz/	1 GHz:	
(Cont'd) When		Fc [GHz]	FM Frequency [Hz]	Jitter Amplitude [Ulp-p] (Max.)	
MU181000A/B-x01		11.3 <fc≤12.5< td=""><td>500 M to 1 G</td><td>0.1</td></fc≤12.5<>	500 M to 1 G	0.1	
is installed:			80 M to 500 M	0.22	
		4.0 <fc≤11.3< td=""><td>80M to 1 G</td><td>0.22</td></fc≤11.3<>	80M to 1 G	0.22	
		2.4 <fc≤4.0< td=""><td>80 M to 500 M</td><td>0.22</td></fc≤4.0<>	80 M to 500 M	0.22	
		1.4 <fc≤2.4< td=""><td>80 M to 100 M</td><td>0.22</td></fc≤2.4<>	80 M to 100 M	0.22	
External Jitter 2	When Operation is S	-ATA (clock output f	requency is fixe	d to 6 GHz)	
When MU181000A/B-x01	Modulation frequency	600 MHz			
is installed:	Modulation accuracy	$0.455 \text{ UIp-p} \pm 0.091$	l UI when input	level is 2 Vp-p	
Triangle Wave Modulation	When Operation is P PCIe-Gen3/4/5 (8 GF		z), PCIe – Gen2	(5 GHz), or	
When	Clock output	PCIe – Gen1 (2.5 G	Hz)		
MU181000A/B-x01	frequency	When Spread Method is Center: 2500 MHz			
or MU181000B-x02 is installed:		When Spread Method is Down: 2493.75 MHz			
		PCIe – Gen2 (5 GH		2100.70 14112	
		When Spread Method is Center: 5000 MHz When Spread Method is Down: 4987.5 MHz			
		PCIe – Gen3/4/5 (8		4507.5 WIIIZ	
		When Spread Me		8000 MHz	
		When Spread Me		7980 MHz	
		Offset function –10			
		effective.	00 to 11000 ppr	m i ppm step is	
	Modulation	31.25 kHz±1000 pp	m		
	frequency accuracy	33 kHz±1000 ppm*	3		
	Frequency	When set to 5000 p	pm:		
	deviation	PCIe – Gen1 (2.5	GHz):	$\pm 6.25~\mathrm{MHz}$	
		PCIe – Gen2 (5 G	Hz):	$\pm 12.5~\mathrm{MHz}$	
		PCIe – Gen3/4/5		±20 MHz	
		When set to 3000 p		_ _ 0 11111	
		PCIe – Gen1 (2.5	•	$\pm 3.75~\mathrm{MHz}$	
		PCIe – Gen2 (5 G		±7.5 MHz	
		PCIe – Gen3/4/5		±12 MHz	
	Deviation accuracy	±10%	(C ()112/ ·	-12 MIII	
	Deviation options	5000 ppm or 3000 ppm*4			
	Deviation options	and thur or added	י זוו לי		

^{*3:} Available only when the MU181000B·x02 is installed.

^{*4:} Switchable only when MP1900A is used. Fixed to 5000 ppm in other cases.

Table 1.3-1 Specifications (Cont'd)

Item		Specifications
Alarm detection function		PLL unlock, temperature detection (judgement temperature +78.5°C)
Environmental performance	Operating temperature range	+5 to +40°C (Main unit ambient temperature)
When MU181000A/B-x01	Operating humidity range	20 to 80%
is installed:	Storage temperature range	−20 to +60°C
	Storage humidity range	20 to 80%
Mechanical dimensions	Dimensions	234 mm (W) \times 41 mm (H) \times 175 mm (D) (Compact-PCI 2 slots), excluding protruding parts
	Mass	≤3.0 kg

Chapter 2 Preparation before Use

This section describes preparations required before using the MU181000A/B.

2.1	Installation to Signal Quality Analyzer	2-2
2.2	How to Operate Application	2-2
2.3	Preventing Damage	2-3

2.1 Installation to Signal Quality Analyzer

For information on how to install the MU181000A/B to the signal quality analyzer and how to turn on the power, refer to 2.3 "Installing and Removing Modules" in the *MP1800A Signal Quality Analyzer Installation Guide* or Chapter 3 " Preparation before Use" in the *MP1900A Signal Quality Analyzer-R Operation Manual.*

2.2 How to Operate Application

The modules connected to the Signal Quality Analyzer are controlled by operating the MX180000A Signal Quality Analyzer Control Software (hereinafter, referred to as "MX180000A") or MX190000A Signal Quality Analyzer-R Control Software (hereinafter, referred to as "MX190000A").

For information on how to start up, shut down, and operate the MX180000A, refer to the MX180000A Signal Quality Analyzer Control Software Operation Manual or MX190000A Signal Quality Analyzer-R Control Software Operation Manual.

2.3 Preventing Damage

Be sure to observe the rating voltage ranges when connecting input and output of the MU181000A/B. Otherwise, the MU181000A/B may become damaged.



CAUTION

- When signals are input to the MU181000A/B, avoid excessive voltage beyond the rating. Otherwise, the circuit may be damaged.
- Use a 50 Ω /GND terminator at the output. Never feed any current to the output.
- As a countermeasure against static electricity, ground other devices to be connected (including experimental circuits) with ground wires before connecting the I/O connector.
- The outer conductor and core of the coaxial cable may become charged as a capacitor. Use metal like a copper wire to discharge electricity between the outer conductor and core before use.
- Never open the MU181000A/B. If you open it and sufficient performance cannot be obtained, we may decline to repair the MU181000A/B.
- To protect the MU181000A/B from electrostatic discharge failure, a conductive sheet should be placed onto the workbench, and the operator should wear an electrostatic discharge wrist strap. Connect the ground connection end of the wrist strap to the conductive sheet or to the ground terminal of the mainframe.

Chapter 3 Panel Layout and Connectors

This section describes the panels and connectors of the MU181000A/B.

3.1	Panel	Layout	3-2
	3.1.1	Panel layout of MU181000A/B	3-2
	3.1.2	Panel layout of MU181000A/B-x01	3-3
	3.1.3	Panel layout of MU181000B-x02	3-5
3.2	Inter-N	Module Connection	3-6

3.1 Panel Layout

3.1.1 Panel layout of MU181000A/B



Figure 3.1.1-1 Panel of MU181000A

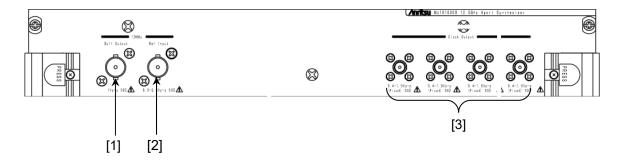


Figure 3.1.1-2 Panel of MU181000B

Table 3.1.1-1 Name and Function of Each Part

No.	Name	Function
[1]	Buff Output (10 MHz)	Connector to output 10 MHz buffer.
[2]	Ref. Input (10 MHz)	Connector to input a 10-MHz reference input signal. Clock output of the MU181000A/B is synchronized with the clock input from this connector.
[3]	Clock Output (100 MHz to 12.5 GHz)	Connector to output a clock signal generated within the MU181000A/B.

3.1.2 Panel layout of MU181000A/B-x01

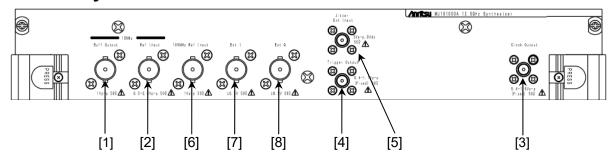


Figure 3.1.2-1 Panel of MU181000A-x01

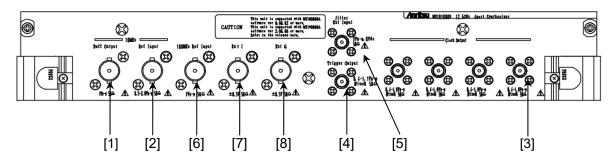


Figure 3.1.2-2 Panel of MU181000B-x01

Table 3.1.2-1 Name and Function of Each Part

No.	Name		Function			
[1]	Buff Output (10 MHz)	Connector to output 10 MHz buffer.				
[2]	Ref. Input (10 MHz)	of the MU18	Connector to input a 10-MHz reference input signal. Clock output of the MU181000A/B is synchronized with the reference clock input from this connector.			
[3]	Clock Output (100 MHz to 12.5 GHz)	Connector to MU181000A	o output a clock signal generated wi /B.	thin the		
[4]	Trigger Output		output a signal generated by divid t frequency by 1 or 64.	ing the clock		
		Jitter Source	Jitter Amplitude	Output Signal		
		Internal	≤ 0.22 UIp-p	Unmodulated		
			> 0.22 UIp-p	Jitter added		
		External Range: 0.22 UI Unmodulated				
			Range: 2 UI / 20 UI / 200 UI / 4000 UI	Jitter added		
[5]	Jitter Ext Input	Connector to supply the modulation signal source externally. A sine wave from 9 Hz to 1 GHz can be input. The jitter amplitude can be controlled by the signal amplitude and by setting Amplitude Range on the screen.				
[6]	100 MHz Ref Input	Connector to input a 100 MHz reference signal. A clock signal is generated from this reference signal by multiplying the frequency and the phase deviation of the signal by 25 or 50, and then the generated clock signal is output from the clock signal output connector. Also, when the MU181000B-x02 is installed, the signal multiplied by 80 is output.				
[7]	Ext I	Connector to input the I signal.				
[8]	Ext Q	Connector to input the Q signal.				

3.1.3 Panel layout of MU181000B-x02



Figure 3.1.3-1 Panel of MU181000B-x02

Table 3.1.3-1 Name and Function of Each Part

No.	Name	Function
[1]	Buff Output (10 MHz)	Connector to output 10 MHz buffer.
[2]	Ref. Input (10 MHz)	Connector to input a 10-MHz reference input signal. Clock output of the MU181000A/B is synchronized with the reference clock input from this connector.
[3]	Clock Output (100 MHz to 12.5 GHz)	Connector to output a clock signal generated within the MU181000A/B.
[4]	100 MHz Ref Input	Connector to input a 100 MHz reference signal. A clock signal is generated from this reference signal by multiplying the frequency and the phase deviation of the signal by 25, 50, or 80, and then the generated clock signal is output from the clock signal output connector.

3.2 Inter-Module Connection

This section shows an example of connecting the MU181000A/B, MU181020A 12.5Gbit/s PPG (hereinafter, referred to as "MU181020A"), and MU181800A 12.5GHz Clock Distributor (hereinafter, referred to as "MU181800A") that are inserted into a mainframe. Connect these modules using the procedure below and referring to Figure 3.2-1 through 3.2-3. In this section, drawings of the MU181000A are used for explanation, while the contents are common to the MU181000B.

- Connecting power supply
 Connect the 3-pin power cord of the mainframe to the power receptacle. Be sure to use the 3-pin power cord supplied with the mainframe and a 3-pin receptacle.
- Connecting to MU181020A
 Connect the Clock Output connector of the MU181000A/B and the Ext. Clock Input connector of the MU181020A, using a coaxial cable.

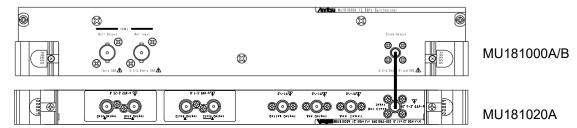


Figure 3.2-1 Connecting to MU181020A

3. Connecting to MU181800A

Connect the Clock Output connector of the MU181000A/B and the Clock Input connector of the MU181800A, using a coaxial cable.



Figure 3.2-2 Connecting to MU181800A

4. Connecting to external device
Connect the Ref. Input connector of the MU181000A/B and the Ref.
Output connector of an external device, using a coaxial cable.

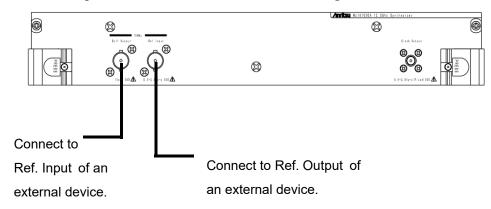


Figure 3.2-3 Connecting to external device

- Connect the MU181000A/B with MU181000A/B-x01 installed and an
 external device in accordance with the intended use. The connection
 method is as follows.
 - (1) To synchronize the MU181000A/B with a 10-MHz reference signal of an external device, connect the Ref. Input connector of the MU181000A/B and the Ref. Output connector of an external device, using a 50 Ω coaxial cable.
 - (2) To synchronize an external device to the 10-MHz reference signal of the MU181000A/B, connect the Buff. Output connector of the MU181000A/B and the Ref. Input connector of an external device, using a 50 Ω coaxial cable.
 - (3) To use the trigger output signal (output clock frequency divided by 1 or 64) as a trigger of an oscilloscope, connect the Trigger Output connector of the MU181000A/B to the trigger input of the oscilloscope, using a 50 Ω coaxial cable.
 - (4) To add jitters using an external signal source, connect the signal source to the Jitter Ext Input connector of the MU181000A/B, using a 50 Ω coaxial cable.
 - (5) To output a clock signal obtained by multiplying the frequency of the 100 MHz signal input from an external signal source by 25 or 50, connect the signal source to the 100 MHz Ref Input connector of the MU181000A/B, using a 50 Ω coaxial cable.
 - (6) To add jitters using an external arbitral waveform signal generator, connect the signal generator to the Ext I and Ext Q connectors of the MU181000A/B, using a 50 Ω coaxial cable.

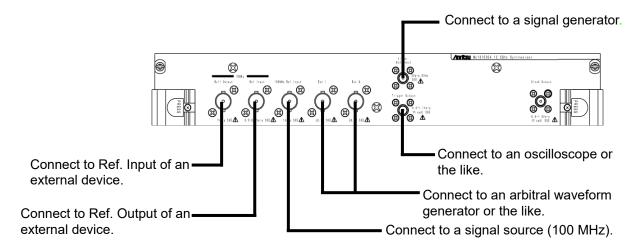


Figure 3.2-4 Connecting to external device (when MU181000A-x01 installed)



If an excessive voltage is applied to the input connector, the protective circuit may be damaged. Avoid any input beyond the rating. If there is any possibility of the rating being exceeded, check that the input signal is within the rating before connection.

To prevent damage due to static electricity charged inside the coaxial cable, ground the core of the coaxial cable in contact to discharge it before connection.

Chapter 4 Configuration of Setup Dialog Box

This section describes the configuration of the setup dialog box for the MU181000A/B.

The operations in the case where the MU181000A/B is installed to the MP1800A are explained here. For the case where the MU181000A/B is installed to the MP1900A, refer to the MX190000A Signal Quality Analyzer-R Control Software Operation Manual.

4.1	Config	uration of Entire Setup Dialog Box	4-2
4.2	Configuration of Operation Window		
	4.2.1	Operation window for MU181000A/B	4-4
	4.2.2	Operation window when MU181000A/B-x01	is
		installed	4-5
	4.2.3	Operation window when MU181000B-x02 is	
		installed	. 4-12

4.1 Configuration of Entire Setup Dialog Box

The figure below shows the configuration of the setup dialog box when the MU181000A/B is inserted into the MP1800A.

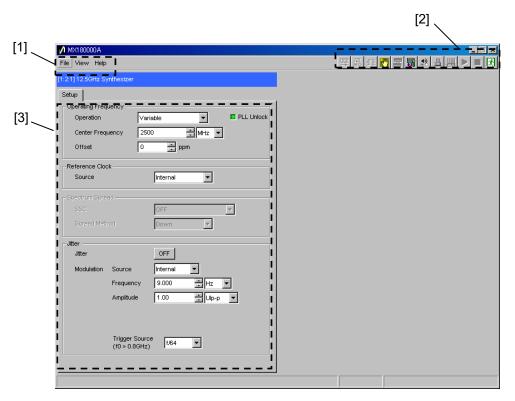


Figure 4.1-1 Configuration of entire setup dialog box for MU181000A/B (MP1800A)

The figure below shows the configuration of the setup dialog box when the MU181000A/B is inserted into the MP1900A.

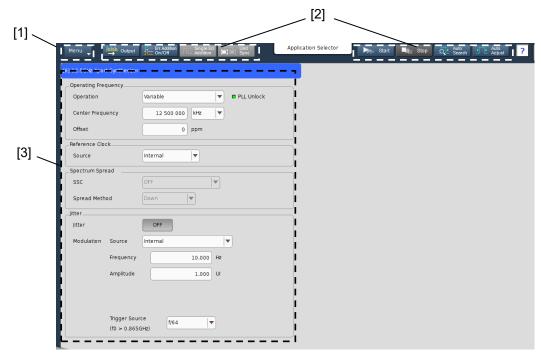


Figure 4.1-2 Configuration of entire setup dialog box for MU181000A/B (MP1900A)

The setup dialog box consists of three blocks as shown in Figure 4.1-1. The following table describes each of the blocks.

Table 4.1-1 Functions of blocks

No.	Block	Function
[1]	Menu bar	Selects the settings related to the entire device. Refer to the MX180000A Signal Quality Analyzer Control Software Operation Manual or MX190000A Signal Quality Analyzer R Control Software Operation Manual for details.
[2]	Module function buttons	Shortcut buttons for the function items specific to the displayed module. Users can customize the pre-defined function buttons according to their own applications. Refer to the MX180000A Signal Quality Analyzer Control Software Operation Manual or MX190000A Signal Quality Analyzer R Control Software Operation Manual for details.
[3]	Operation window	Configures settings specific to each module.

4.2 Configuration of Operation Window

4.2.1 Operation window for MU181000A/B

The operation window for the MU181000A/B is shown below.

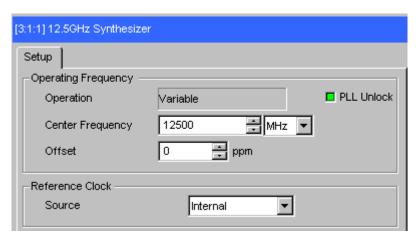


Figure 4.2.1-1 Operation window

Table 4.2.1-1 Items in operation window

Item			Functions	
Operating Frequency	Center Frequency	Sets the frequency of the clock signal output from the Clock Output connector (when Offset = 0 ppm).		
		In MHz units:	Can be set in the range from 100 to 12,500 MHz. Digits below MHz that are not displayed are set to 0.	
		In kHz units:	Can be set in the range from 100,000 to 12,500,000 kHz.	
	Offset	Sets the offset value from Center Frequency for the frequency of the signal output from the Clock Output connector. Unit: ppm		
		Setting range:	-1,000 to +1,000 ppm, in 1 ppm steps	
	PLL Unlock	Green:	PLL lock state	
		Red:	PLL unlock state	
Reference Source Internal:		Internal:	Synchronizes the clock signal output from the Clock Output connector with the 10 MHz reference signal in the main frame.	
		External 10 MHz	E Synchronizes the clock signal output from the Clock Output connector with the 10 MHz clock signal input to the Ref. Input (10 MHz) connector from an external device.	

4.2.2 Operation window when MU181000A/B-x01 is installed

The operation window for the MU181000A/B with MU181000A/B-x01 installed is shown below.

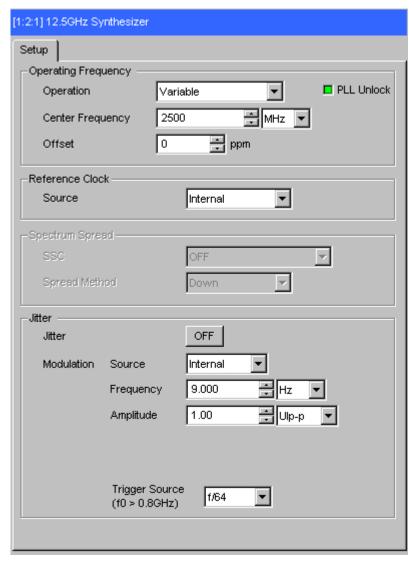


Figure 4.2.2-1 Operation window (MU181000A/B-x01 installed)

Table 4.2.2-1 Items in operation window when MU181000A/B-x01 is installed

Ite	em	Functions
Operating Frequency	Operation	Select Variable, PCIe-Gen1 (2.5 GHz), PCIe-Gen2 (5 GHz), or SATA (6 GHz).
	Center	When Operation is set to Variable:
	Frequency	Sets the frequency of the clock signal output from the Clock Output connector (when Offset = 0 ppm).
		In MHz units: Can be set in the range from 100 to 12,500 MHz. Digits below MHz that are not displayed are set to 0.
		In kHz units: Can be set in the range from 100,000 to 12,500,000 kHz.
		When Operation is set to PCIe-Gen1 (2.5 GHz): Fixed to 2500 MHz.
		When Operation is set to PCIe-Gen2 (5 GHz): Fixed to 5000 MHz.
		When Operation is set to SATA (6 GHz): Fixed to 6000 MHz.
	Offset	Sets the offset value from Center Frequency for the frequency of the clock signal output from the Clock Output connector. Unit: ppm
		Setting range: -1,000 to +1,000 ppm, in 1 ppm steps
		This item is disabled when Operation is set to PCIe-Gen1 (2.5 GHz) or PCIe-Gen2 (5 GHz) and SSC is set to ON (Ext Ref 100 MHz).
	PLL Unlock	Green: PLL lock state
		Red: PLL unlock state
Reference Clock	Source	Internal: Synchronizes the clock signal output from the Clock Output connector with the 10 MHz reference signal in the main frame.
		External 10 MHz: Synchronizes the clock signal output from the Clock Output connector with the 10 MHz clock signal input to the Ref. Input (10 MHz) connector from an external device.
		This item is disabled when Spectrum Spread / SSC is set to "ON (Int Ref)" or "ON (Ext Ref 10 MHz)" or "ON (Ext Ref 100 MHz)".

Table 4.2.2-1 Items in operation window when MU181000A/B-x01 is installed (Cont'd)

If	tem	Functions		
Spectrum Spread	SSC	This item is enabled only when Operation is set to PCIe-Gen1 (2.5 GHz) or PCIe-Gen2 (5 GHz).		
		OFF: An unmodulated clock signal is output. ON (Int Ref):		
		A triangular wave modulated clock signal is output. The carrier is synchronized with the internal 10 MHz reference signal. ON (Ext Ref 10 MHz):		
		A triangular wave modulated clock signal is output. The carrier is synchronized with an externally input 10 MHz clock signal.		
		ON (Ext Ref 100 MHz): A clock signal that is obtained by multiplying the frequency of the 100 MHz signal input from the 100 MHz Ref Input connector by 25 or 50 is output.		
	Spread Method	This item is enabled only when SSC is set to OFF, ON (Int Ref), or ON (Ext Ref 10 MHz).		
		Down: When Operation is set to PCIe-Gen1 (2.5 GHz), a 2493.75 MHz signal is output, synchronized with the selected 10-MHz reference signal. When Operation is set to PCIe-Gen2 (5 GHz), a 4987.5 MHz signal is output, synchronized with the selected 10-MHz reference signal.		
		Center: When Operation is set to PCIe-Gen1 (2.5 GHz), a 2500 MHz signal is output, synchronized with the selected 10 MHz reference signal. When Operation is set to PCIe-Gen2 (5 GHz), a 5000 MHz signal is output, synchronized with the selected 10 MHz reference signal.		
Jitter	Jitter	This item is enabled only when SSC is set to OFF.		
		ON: A clock signal is output with jitter added.		
		OFF: An unmodulated clock signal is output.		
	Modulation Source	Internal: Select when adding jitter with the internal modulation signal source. When Internal is selected, the Frequency and Amplitude spin boxes are displayed as shown in Figure. 4.2.2-2, to set the frequency and amplitude depth of the sine wave jitter.		
		External: Select when adding jitter with an external signal source. When External is selected, the Frequency Range and Amplitude Range spin boxes are displayed as shown in Figure 4.2.2-3. Select the ranges of the frequency and amplitude depth to be modulated by referring to Figure 4.2.2-5 through 4.2.2-9, and set in these spin boxes. Note that Amplitude is fixed to 0.22 UI when Frequency Range is set to Full.		
		External I/Q: Select when using the I and Q signals for modulation. The Jitter field becomes as shown in Figure. 4.2.2-4, which does not provide any items for setting the frequency and amplitude depth.		

Table 4.2.2-1 Items in operation window when MU181000A/B-x01 is installed (Cont'd)

Item		Functions
Jitter	Trigger Source	When Fc is set to greater than 800 MHz, a signal obtained by dividing the clock output frequency (Fc) by 1 or 64 is output from the Trigger Out connector.
		 F/1: A signal with Fc divided by 1 is output. This can be selected only when Fc is set to greater than 6400 MHz. F/64: A signal with Fc divided by 64 is output.

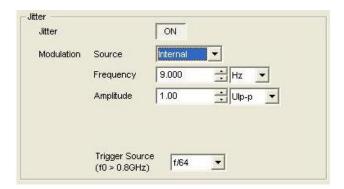


Figure 4.2.2-2 Jitter setting field when Internal is selected

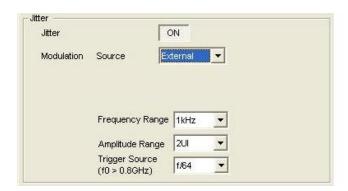


Figure 4.2.2-3 Jitter setting field when External is selected

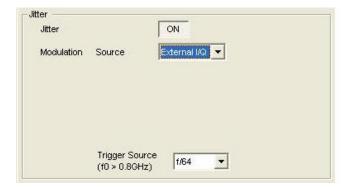


Figure 4.2.2-4 Jitter setting field when External I/Q is selected

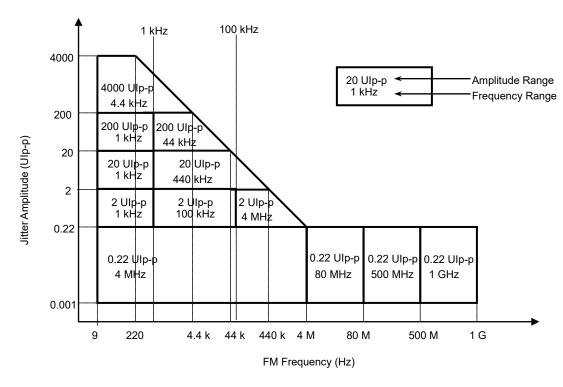


Figure 4.2.2-5 Range selection when 6.4 GHz < Fc ≤ 12.5 GHz

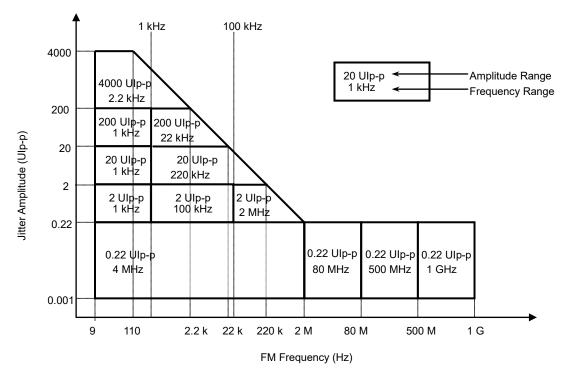


Figure 4.2.2-6 Range selection when 3.2 GHz < Fc \le 6.4 GHz

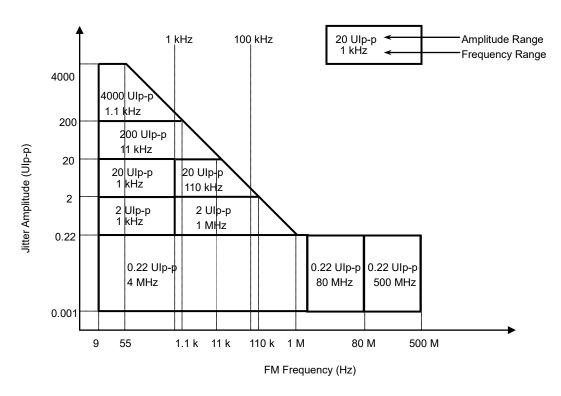


Figure 4.2.2-7 Range selection when 1.6 GHz < Fc \leq 3.2 GHz

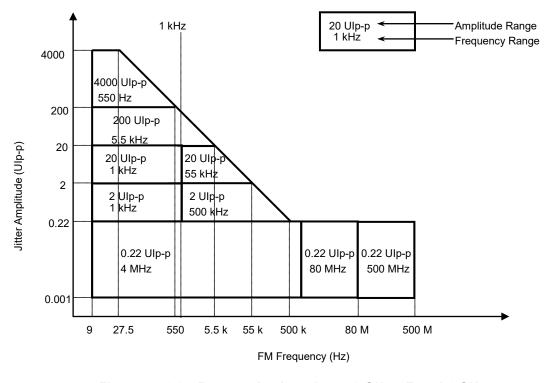


Figure 4.2.2-8 Range selection when 0.8 GHz < Fc ≤ 1.6 GHz

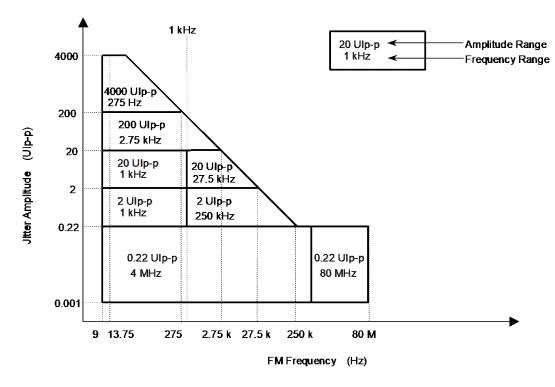


Figure 4.2.2-9 Range selection when 0.1 GHz \leq Fc \leq 0.8 GHz

Note:

For details of the operation method and cautions when inputting a jitter-modulated signal to the MU181020A 12.5Gbit/s PPG (with Option x30 Variable Data Delay installed) or the MU181040A 12.5Gbit/s ED (with Option x30 Variable Clock Delay), see 5.1.5 "When setting jitter-modulated signals" of the MU181020A 12.5Gbit/s PPG Operation Manual or 5.1.9 "When setting jitter-modulated signals" of the MU181040A 12.5Gbit/s ED Operation Manual.

4.2.3 Operation window when MU181000B-x02 is installed

The operation window for the MU181000A/B with MU181000B-x02 installed is shown below.

If the MU181000B-x01 is also installed, refer to the operation window in Section 4.2.2.

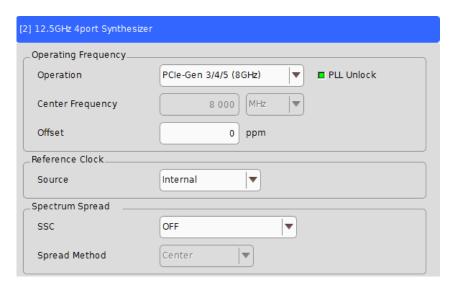


Figure 4.2.3-1 Operation window (MU181000B-x02 installed)

Note:

MU181000B-x02 is usable only when it is installed in MP1900A. If installed in MP1800A, the MP1800A shows no presence of this option on the screen and operates without MU181000B-x02.

Table 4.2.3-1 Items in operation window when MU181000B-x02 is installed

	Item	Functions	
Operating Frequency	Operation	Select Variable, PCIe-Gen1 (2.5 GHz), PCIe-Gen2 (5 GHz), PCIe-Gen3/4/5 (8 GHz), or SATA (6 GHz).	
	Center	When Operation is set to Variable:	
	Frequency	Sets the frequency of the clock signal output from the Clock connector (when Offset = 0 ppm).	Output
		In MHz units: Can be set in the range from 100 to 12,500 Digits below MHz that are not displayed a 0.	
		In kHz units: Can be set in the range from 100,000 to 12,500,000 kHz.	
		When Operation is set to PCIe-Gen1 (2.5 GHz): Fixed to 2500 MHz.	
		When Operation is set to PCIe-Gen2 (5 GHz): Fixed to 5000 MHz.	
		When Operation is set to PCIe-Gen3/4/5 (8 GHz)	
		Fixed to 8000 MHz	
		When Operation is set to SATA (6 GHz)	
		Fixed to 6000 MHz	
	Offset	Sets the offset value from Center Frequency. Unit: ppm	
		Setting range: -1000 to +1000 ppm, in 1 ppm steps	
		This item is disabled when Operation is set to PCIe-Gen1 (2. PCIe-Gen2 (5 GHz), or PCIe-Gen3/4/5 (8 GHz) and SSC is se (Ext Ref 100 MHz).	
	PLL Unlock	Green: PLL lock state	
		Red: PLL unlock state	
Reference Clock	Source	Internal: Synchronizes the clock signal output from the Output connector with the 10 MHz reference in the main frame.	
		External 10 MHz:	
		Synchronizes the clock signal output from the Output connector with the 10 MHz clock sign to the Ref. Input (10 MHz) connector from an external device.	al input
		This item is disabled when Spectrum Spread / SSC is set to 'Ref)" or "ON (Ext Ref 10 MHz)" or "ON (Ext Ref 100 MHz)".	ON (Int

Table 4.2.3-1 Items in operation window when MU181000B-x02 is installed (Cont'd)

Item		Functions
Spectrum Spread	SSC	This item is enabled only when Operation is set to PCIe-Gen1 (2.5 GHz), PCIe-Gen2 (5 GHz), or PCIe-Gen3/4/5 (8 GHz)
		OFF: An unmodulated clock signal is output.
		ON (Int Ref):
		A triangular wave modulated clock signal is output. The carrier is synchronized with the internal 10 MHz reference signal.
		ON (Ext Ref 10 MHz):
		A triangular wave modulated clock signal is output. The carrier is synchronized with an externally input 10 MHz clock signal.
		ON (Ext Ref 100 MHz):
		A clock signal that is obtained by multiplying the frequency of the 100 MHz signal input from the 100 MHz Ref Input connector by 25, 50, or 80 is output.
	Spread Method	This item is enabled only when SSC is set to OFF, ON (Int Ref), or ON (Ext Ref 10 MHz).
Wiethou		Down: When Operation is set to PCIe-Gen1 (2.5 GHz), a 2493.75 MHz signal is output, synchronized with the selected 10-MHz reference signal. When Operation is set to PCIe-Gen2 (5 GHz), a 4987.5 MHz signal is output, synchronized with the selected 10-MHz reference signal.
		When Operation is set to PCIe-Gen3/4/5 (8 GHz) a 7980 MHz signal is output, synchronized with the selected 10-MHz reference signal.
		Center: When Operation is set to PCIe-Gen1 (2.5 GHz), a 2500 MHz signal is output, synchronized with the selected 10 MHz reference signal. When Operation is set to PCIe-Gen2 (5 GHz), a 5000 MHz signal is output, synchronized with the selected
		10 MHz reference signal. When Operation is set to PCIe-Gen3/4/5 (8 GHz) a 8000 MHz signal is output, synchronized with the selected 10 MHz reference signal.

Chapter 5 Use Example

This section provides an MU181000A/B usage example.

5.1	MU18	1000A/B Usage Example	5-2
	5.1.1	Example when using the MU181000A/B as	
		a clock signal source	5-2
	5.1.2	Example when using an external modulation	
		signal source	5-3

5.1 MU181000A/B Usage Example

5.1.1 Example when using the MU181000A/B as a clock signal source

The following shows an example of how to use the MU181000A/B as the clock signal source for the MU181020A. In this section, drawings of the MU181000A are used for explanation, while the contents are common to the MU181000B.

1. Connect the Clock Output connector of the MU181000A/B and the Ext. Clock Input connector of the MU181020A, using a coaxial cable.

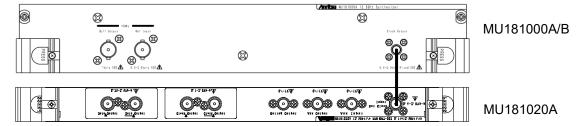


Figure 5.1.1-1 Connection with MU181020A

 Generate Data and Clock signals by referring to the MU181020A 12.5Gbit/s PPG Operation Manual.

5.1.2 Example when using an external modulation signal source

1. When inputting a modulation signal to the Jitter Ext Input connector

The jitter amplitude is determined depending on the Frequency Range and Amplitude Range settings in the operation window and the amplitude of the input signal. Adjust the amplitude of the signal source when more accurate jitter amplitude than the guaranteed accuracy level is required. The jitter amplitude can be obtained by measuring the carrier and sideband power using the spectrum analyzer. In this event, however, if the jitter amplitude is more than 0.4 UIp-p, be sure to divide the frequency so that the jitter amplitude is lowered to 0.4 UIp-p or less before performing measurement with the spectrum analyzer.

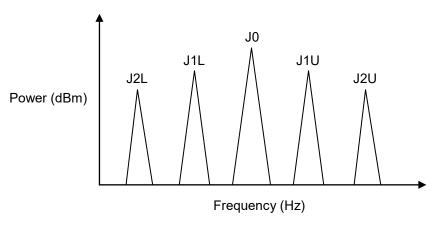


Figure 5.1.2-1 Spectrum waveform

Jo: Carrier power (dBm)

J1U: Power of the upper frequency of the first sideband (dBm)

J1L: Power of the lower frequency of the first sideband (dBm)

J2U: Power of the upper frequency of the second sideband (dBm)

J2L: Power of the lower frequency of the second sideband (dBm)

Jitter amplitude calculation method

J1 = (J1U + J1L)/2

J2 = (J2U + J2L)/2

 $j0 = 10^{(J0/20)}$

 $j1 = 10^{(J1/20)}$

 $2 = 10^{(12/20)}$

Jitter amplitude = $(2 \times j1/(j0 + j2))/\pi \times \text{Division ratio (UIp-p)}$

When the amplitude is set to 0.22 UI, the waveform may be distorted for an amplitude of more than 0.1 UIp-p. In order to adjust the peak-to-peak value of the phase deviation more precisely, correct the calculated jitter amplitude (obtained from the expression above) as follows:

UIm: Jitter amplitude (UIp-p) calculated from the spectrum power described above Jitter amplitude = UIm \times (1 – (0.03 \times UIm – 0.0024) \times 10 (UIp-p))

2. When executing modulation by inputting a signal to the Ext IQ connector

When adding a sine wave jitter, generate the I and Q signals as shown below, using an arbitrary waveform generator, and input them.

Calculate the actual modulation amount from the spectrum power, and check the difference from the set modulation amount before using this unit.

I signal = $0.5 \times \sin (UIs \times \pi \times \sin (2 \times \pi \times t/T))$ (V) Q signal = $0.5 \times \cos (UIs \times \pi \times \sin (2 \times \pi \times t/T))$ (V) UIs: Set jitter amplitude (UIp-p)

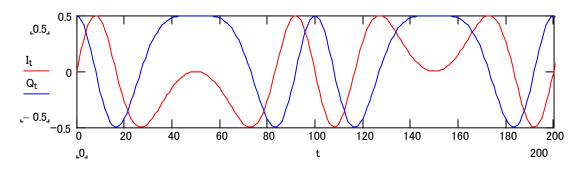


Figure 5.1.2-2 Example of waveforms of I and Q signals when jitter amplitude is 2 Ulp-p

Chapter 6 Performance Test

This section describes the performance testing of the MU181000A/B.

6.1	Overv	iew	6-2
6.2	Device	es Required for Performance Tests	6-3
6.3	Perfor	mance Test Items	6-4
	6.3.1	Measuring waveform	6-4
	6.3.2	Measuring phase noise	6-6
	6.3.3	Measuring internal sine wave jitter	6-7
	6.3.4	Measuring external sine wave jitter	6-12
	6.3.5	Measuring triangular wave modulation	6-17
	6.3.6	Measuring trigger output waveform	6-19

6.1 Overview

Performance tests are executed to check that the major functions of the MU181000A/B meet the required specifications. Execute performance tests at acceptance inspection, operation check after repair, and periodic (once every six months) testing.

6.2 Devices Required for Performance Tests

Before starting performance tests, warm up the MU181000A/B and the measuring instruments for at least 30 minutes. Table 6.2-1 shows the devices required for performance tests.

Table 6.2-1 Devices required for MU181000A/B performance test

Device	Required Performance
Sampling oscilloscope	50 GHz or more band
Spectrum analyzer	50 GHz or more band
Divider	10,000 or more divisions
Signal generator	2 GHz or more
Function generator	9 Hz or less

Note:

Before starting the performance tests, warm up the device under test and the measuring instruments for at least 30 minutes and wait until they become sufficiently stabilized, unless otherwise specified. Additional conditions are required for maximum measurement accuracy: measurements must be performed at room temperature, fluctuations of AC power supply voltage must be small, and noise, vibration, dust, and humidity must be insignificant.

6.3 Performance Test Items

This section describes the following test items. In this section, drawings of the MU181000A are used for explanation, while the contents are common to the MU181000B.

- (1) Waveform
- (2) Phase noise
- (3) Internal sine wave jitter
- (4) External sine wave jitter
- (5) Triangular wave modulation
- (6) Trigger output waveform

Note:

MU181000A/B-x01 must be installed when executing test items (3) to (6).

6.3.1 Measuring waveform

Measure the waveform at the Clock Output connector. Connection with the measuring instruments is shown in Figure 6.3.1-1.

MU181000A/B

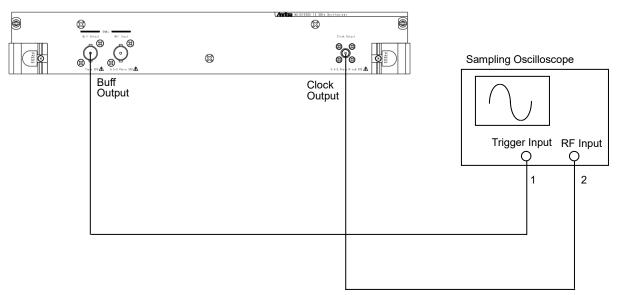


Figure 6.3.1-1 Connection diagram for waveform measurement

1. Connect the signal output from the Buff Output connector to the Trigger Input connector of the sampling oscilloscope.

Connect the clock signal output from the Clock Output connector to the RF Input connector of the sampling oscilloscope. Set the averaging to 64 (times) for the sampling scope.

CAUTION

Use an appropriate attenuator for each input connector when connecting to the input connector of the sampling oscilloscope. Improper connection may damage the sampling oscilloscope.

Set as follows in the MU181000A/B operation window:

Center Frequency: $12,500 \mathrm{\ MHz}$

Offset: 0 ppm Reference Clock Source: Internal

Use the averaging function of the sampling oscilloscope to measure the waveform, and then check that the level of the measured waveform falls within the range shown in Figure 6.3.1-2.

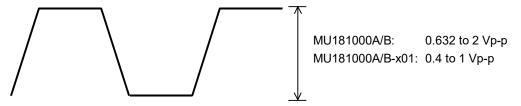


Figure 6.3.1-2 Example of waveform measured by sampling oscilloscope

Change the Center Frequency value in the MU181000A/B operation window as shown below, and perform measurement in the same way. Check that the waveform level falls within the range shown in Figure 6.3.1-2.

Center Frequency: 10,000 MHz, 5,000 MHz, 1,000 MHz, 100 MHz

6.3.2 Measuring phase noise

Measure the phase noise at the Clock Output connector. Connection with the measuring instruments is shown in Figure 6.3.2-1.

MU181000A/B

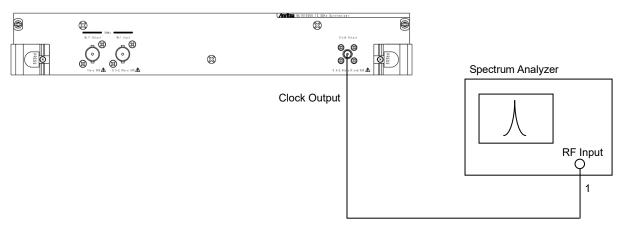


Figure 6.3.2-1 Connection diagram for phase noise measurement

- 1. Connect the clock signal output from the Clock Output connector to the RF Input connector of the spectrum analyzer.
- 2. Set as follows in the MU181000A/B operation window:

Center Frequency: 12,500 MHz
Offset: 0 ppm
Reference Clock Source: Internal

- 3. Check that the phase noise measured by the spectrum analyzer falls within one of the ranges shown below:
 - ≤–61 dBc/Hz at 1 kHz offset
 - ≤–81 dBc/Hz at 10 kHz offset
 - ≤-90 dBc/Hz at 100 kHz offset
- 4. Change the Center Frequency value in the MU181000A/B operation window as shown below, and perform measurement in the same way. Check that the phase noise falls within the range shown in Step 3 above.

Center Frequency: 10,000 MHz, 5,000 MHz, 1,000 MHz, 100 MHz



Use an appropriate attenuator for each input connector when connecting to the input connector of the spectrum analyzer. Improper connection may damage the spectrum analyzer.

6.3.3 Measuring internal sine wave jitter

Measure the jitter amplitude at the Clock Output connector. Connection with the measuring instrument is shown in Figure 6.3.3-1 and Figure 6.3.3-2.

MU181000A/B (with MU181000A-/B-x01 installed)

| Mathematical Section | Mathematical Sectio

Figure 6.3.3-1 Connection diagram for internal sine wave jitter measurement of 0.4 Ulp-p or less

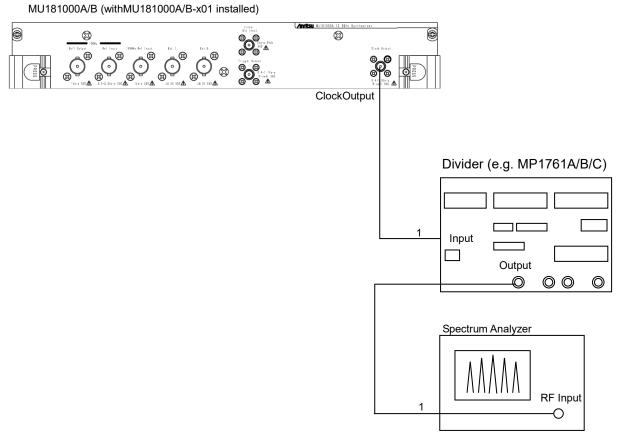


Figure 6.3.3-2 Connection diagram for internal sine wave jitter measurement of more than 0.4 Ulp-p

1. When the jitter amplitude is set to 0.4 UIp-p or less, connect the clock signal output from the Clock Output connector to the RF Input connector of the spectrum analyzer.

When the jitter amplitude is set to more than 0.4 UIp-p, connect the clock signal output from the Clock Output connector to the Input connector of the divider, and connect the Output connector of the divider and the RF Input connector of the spectrum analyzer.

2. Set as follows in the MU181000A/B operation window:

Operation: Variable

Center Frequency: See Table 6.3.3-1.

Offset: 0 ppm
Reference Clock Source: Internal
Jitter: ON
Modulation Source: Internal

Frequency: See Table 6.3.3-1.
Amplitude: See Table 6.3.3-1.

Table 6.3.3-1 Setting points for internal jitter measurement

Center Frequency	Frequency	Jitter Amplitude
12500 MHz	$9\mathrm{Hz}$	4000 UIp-p
	$220~\mathrm{Hz}$	4000 UIp-p
	1 kHz	880 UIp-p
	10 kHz	88 UIp-p
	100 kHz	8.8 UIp-p
	1 MHz	0.88 UIp-p
	4 MHz	0.22 UIp-p
	10 MHz	0.22 UIp-p
	20 MHz	0.22 UIp-p
	50 MHz	0.22 UIp-p
	80 MHz	0.22 UIp-p
9953.28 MHz	10 Hz	22 UIp-p
	$40~\mathrm{kHz}$	22 UIp-p
	4 MHz	0.22 UIp-p
	10 MHz	0.22 UIp-p
	80 MHz	0.22 UIp-p
6400 MHz	9 Hz	4000 UIp-p
	110 Hz	4000 UIp-p
	1 kHz	440 UIp-p
	10 kHz	44 UIp-p
	100 kHz	4.4 UIp-p
	1 MHz	0.44 UIp-p
	2 MHz	0.22 UIp-p
	5 MHz	0.22 UIp-p
	10 MHz	0.22 UIp-p
	20 MHz	0.22 UIp-p
	40 MHz	0.22 UIp-p
3200 MHz	9 Hz	4000 UIp-p
	55 Hz	4000 UIp-p
	100 Hz	2200 UIp-p
	1 kHz	220 UIp-p
	10 kHz	22 UIp-p
	100 kHz	2.2 UIp-p
	1 MHz	0.22 UIp-p
Ī	5 MHz	0.22 UIp-p
Ţ	10 MHz	0.22 UIp-p
2488.32 MHz	10 Hz	22 UIp-p
Ţ	10 kHz	22 UIp-p
-	1 MHz	0.22 UIp-p
	10 MHz	0.22 UIp-p
Ţ	20 MHz	0.22 UIp-p

Table 6.3.3-1 Setting points for internal jitter measurement (Cont'd)

Center Frequency	Frequency	Jitter Amplitude
1600 MHz	9 Hz	4000 UIp-p
	27.5 Hz	4000 UIp-p
	100 Hz	1100 UIp-p
	1 kHz	110 UIp-p
	$10~\mathrm{kHz}$	11 UIp-p
	100 kHz	1.1 UIp-p
	$500~\mathrm{kHz}$	0.22 UIp-p
	$1\mathrm{MHz}$	0.22 UIp-p
	$2~\mathrm{MHz}$	0.22 UIp-p
	$5\mathrm{MHz}$	0.22 UIp-p
	$10~\mathrm{MHz}$	0.22 UIp-p
1244.16 MHz	10 Hz	22 UIp-p
	5 kHz	22 UIp-p
	$500~\mathrm{kHz}$	0.22 UIp-p
	10 MHz	0.22 UIp-p
800 MHz	9 Hz	4000 UIp-p
	$13.75~\mathrm{Hz}$	4000 UIp-p
	100 Hz	550 UIp-p
	1 kHz	55 UIp-p
	$10~\mathrm{kHz}$	5.5 UIp-p
	$100~\mathrm{kHz}$	0.55 UIp-p
	$250~\mathrm{kHz}$	0.22 UIp-p
	$1\mathrm{MHz}$	0.22 UIp-p
	$2~\mathrm{MHz}$	0.22 UIp-p
	$5\mathrm{MHz}$	0.22 UIp-p
$622.08~\mathrm{MHz}$	$10~\mathrm{Hz}$	22 UIp-p
	$2.5~\mathrm{kHz}$	22 UIp-p
	$250~\mathrm{kHz}$	0.22 UIp-p
	$5\mathrm{MHz}$	0.22 UIp-p
$155.52~\mathrm{MHz}$	$10~\mathrm{Hz}$	22 UIp-p
	$2.5~\mathrm{kHz}$	22 UIp-p
	$250~\mathrm{kHz}$	0.22 UIp-p
	5 MHz	0.22 UIp-p
100 MHz	10 Hz	22 UIp-p
	200 Hz	22 UIp-p
	20 kHz	0.22 UIp-p
	$1\mathrm{MHz}$	0.22 UIp-p
	5 MHz	0.22 UIp-p

3. Measure the carrier and sideband power using the spectrum analyzer, and calculate the jitter amplitude by referring to the description in 5.1.2 "Example when using an external modulation signal source" Next, check that the calculation result falls within one of the ranges shown below.

When Center Frequency is less than 1 GHz:

 ± 0.01 UI $\pm Q\%$ when the set amplitude is 0.001 to 2.19 UIp-p ± 0.2 UI $\pm Q\%$ when the set amplitude is 2.2 to 21.99 UIp-p ± 2 UI $\pm Q\%$ when the set amplitude is 22 to 4000 UIp-p

When Center Frequency is 1 GHz or higher:

±0.02 UI±Q% when the set amplitude is 0.001 to 2.19 UIp-p ±0.2 UI±Q% when the set amplitude is 2.2 to 21.99 UIp-p ±2 UI±Q% when the set amplitude is 22 to 4000 UIp-p

Note that the value of Q differs depending on the modulation frequency, as follows:

9 Hz \leq Frequency \leq 500 kHz: 7 500 kHz \leq Frequency \leq 2 MHz: 12 2 MHz \leq Frequency \leq 80 MHz: 15



CAUTION

Use an appropriate attenuator for each input connector when connecting to the input connector of the spectrum analyzer. Improper connection may damage the spectrum analyzer.

6.3.4 Measuring external sine wave jitter

Measure the jitter amplitude at the Clock Output connector. Connection with the measuring instruments is shown in Figure 6.3.4-1 and Figure 6.3.4-2.

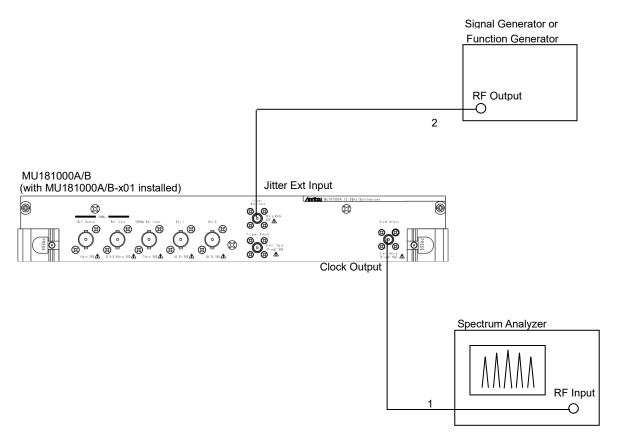


Figure 6.3.4-1 Connection diagram for external sine wave jitter measurement of 0.4 Ulp-p or less

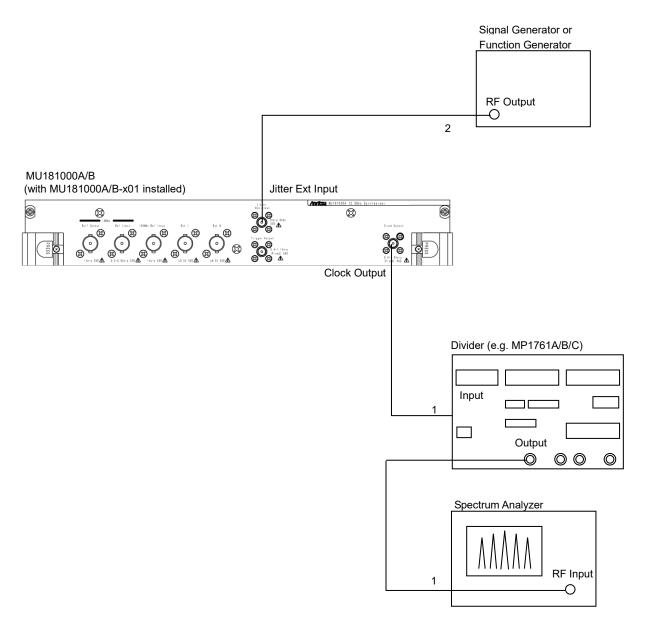


Figure 6.3.4-2 Connection diagram for external sine wave jitter measurement of more than 0.4 Ulp-p

- 1. When the jitter amplitude is set to 0.4 UIp-p or less, connect the clock signal output from the Clock Output connector to the RF Input connector of the spectrum analyzer.
 - When the jitter amplitude is set to more than 0.4 UIp-p, connect the clock signal output from the Clock Output connector to the Input connector of the divider, and connect the Output connector of the divider and the RF Input connector of the spectrum analyzer.
- 2. Connect the sine wave output of the external modulation signal source, signal generator or function generator, to the Jitter Ext Input connector of the MU181000A/B. When a 50-Ω load is attached to the edge of the cable on the Jitter Ext Input side, perform calibration before input so that 0.5 Vp-p is obtained. See Table 6.3.4-1 for the output frequency of the modulation signal source.
- 3. Set as follows in the MU181000A/B operation window:

Operation: Variable

Center Frequency: See Table 6.3.4-1.

Offset: 0 ppm
Reference Clock Source: Internal
Jitter: ON
Modulation Source: External

Frequency: See Table 6.3.4-1.
Amplitude: See Table 6.3.4-1.

4. Measure the carrier and sideband power using the spectrum analyzer, and calculate the jitter amplitude by referring to the description in Section 5.1.2 "Example when using an external modulation signal source." Then check that the calculation result falls within one of the ranges shown in Table 6.3.4-1.

Table 6.3.4-1 Setting points for external jitter measurement

Center Frequency	Frequency Range	Amplitude Range	Input Frequency	Amplitude
12500 MHz	4.4 kHz	4000 UI	220 Hz	1000 UIp-p±300 UI
	44 kHz	200 UI	4.4 kHz	100 UIp-p±30 UI
	440 kHz	20 UI	44 kHz	10 UIp-p±3 UI
	4 MHz	2 UI	440 kHz	1 UIp-p±0.3 UI
	4 MHz	0.22 UI	4 MHz	0.1 UIp-p±0.03 UI
	80 MHz	0.22 UI	80 MHz	0.1 UIp-p±0.03 UI
	$500~\mathrm{MHz}$	0.22 UI	500 MHz	0.1 UIp-p±0.03 UI
	1 GHz	0.22 UI	1 GHz	0.1 UIp-p±0.03 UI
6400 MHz	2.2 kHz	4000 UI	110 Hz	1000 UIp-p±300 UI
	$22~\mathrm{kHz}$	200 UI	2.2 kHz	100 UIp-p±30 UI
	$220~\mathrm{kHz}$	20 UI	22 kHz	10 UIp-p±3 UI
	2 MHz	2 UI	220 kHz	1 UIp-p±0.3 UI
	4 MHz	0.22 UI	4 MHz	0.1 UIp-p±0.03 UI
	80 MHz	0.22 UI	80 MHz	0.1 UIp-p±0.03 UI
	500 MHz	0.22 UI	500 MHz	0.1 UIp-p±0.03 UI
	1 GHz	0.22 UI	1 GHz	0.1 UIp-p±0.03 UI
$3200~\mathrm{MHz}$	1.1 kHz	4000 UI	55 Hz	1000 UIp-p±300 UI
	11 kHz	200 UI	1.1 kHz	100 UIp-p±30 UI
	110 kHz	20 UI	11 kHz	10 UIp-p±3 UI
	1 MHz	2 UI	110 kHz	1 UIp-p±0.3 UI
	4 MHz	0.22 UI	4 MHz	0.1 UIp-p±0.03 UI
	80 MHz	0.22 UI	80 MHz	0.1 UIp-p±0.03 UI
	500 MHz	0.22 UI	500 MHz	0.1 UIp-p±0.03 UI

Table 6.3.4-1 Setting points for external jitter measurement (Cont'd)

Center Frequency	Frequency Range	Amplitude Range	Input Frequency	Amplitude
$1600~\mathrm{MHz}$	550 Hz	4000 UI	27.5 Hz	1000 UIp-p±300 UI
	$5.5~\mathrm{kHz}$	200 UI	$550~\mathrm{Hz}$	100 UIp-p±30 UI
	$55~\mathrm{kHz}$	20 UI	$5.5~\mathrm{kHz}$	10 UIp-p±3 UI
	500 kHz	2 UI	$55~\mathrm{kHz}$	1 UIp-p±0.3 UI
	$4~\mathrm{MHz}$	0.22 UI	4 MHz	0.1 UIp-p±0.03 UI
	80 MHz	0.22 UI	80 MHz	0.1 UIp-p±0.03 UI
	$500~\mathrm{MHz}$	0.22 UI	100 MHz	0.1 UIp-p±0.03 UI
800 MHz	275 Hz	4000 UI	13.75 Hz	1000 UIp-p±300 UI
	$2.75~\mathrm{kHz}$	200 UI	275 Hz	100 UIp-p±30 UI
	$27.5~\mathrm{kHz}$	20 UI	$2.75~\mathrm{kHz}$	10 UIp-p±3 UI
	$250~\mathrm{kHz}$	2 UI	$27.5~\mathrm{kHz}$	1 UIp-p±0.3 UI
	$4~\mathrm{MHz}$	0.22 UI	4 MHz	0.1 UIp-p±0.03 UI
	80 MHz	0.22 UI	20 MHz	0.1 UIp-p±0.03 UI
$100~\mathrm{MHz}$	$275~\mathrm{Hz}$	4000 UI	13.75 Hz	1000 UIp-p±300 UI
	$2.75~\mathrm{kHz}$	200 UI	275 Hz	100 UIp-p±30 UI
	27.5 kHz	20 UI	$2.75~\mathrm{kHz}$	10 UIp-p±3 UI
	250 kHz	2 UI	27.5 kHz	1 UIp-p±0.3 UI
	4 MHz	0.22 UI	4 MHz	0.1 UIp-p±0.03 UI
	80 MHz	0.22 UI	5 MHz	0.1 UIp-p±0.03 UI



CAUTION

Use an appropriate attenuator for each input connector when connecting to the input connector of the spectrum analyzer. Improper connection may damage the spectrum analyzer.

6.3.5 Measuring triangular wave modulation

Measure the phase deviation at the Clock Output connector. Connection with the measuring instruments is shown in Figure 6.3.5-1.

MU181000A/B (with MU181000A/B-x01 installed)

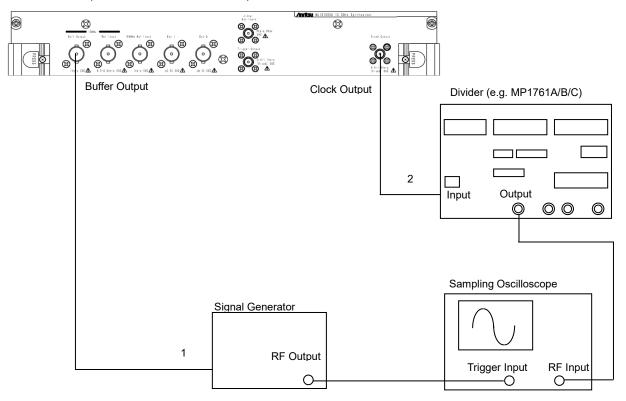


Figure 6.3.5-1 Connection diagram for triangular wave modulation measurement

- 1. Connect the Buff Output signal to the RF Input connector of the signal generator.
 - Set the output frequency of the signal generator to 9.765625 MHz, and the output level to within the operation guaranteed range of the sampling oscilloscope. Next, connect the RF Output connector of the signal generator and the Trigger Input connector of the sampling oscilloscope.
- 2. Connect the Clock Output signal to the Input connector of the divider. Next, connect the Output of the divider and the RF Input connector of the sampling oscilloscope.
 - See Table 6.3.5-1 for the division ratio of the divider.



CAUTION

Use an appropriate attenuator for each input connector when connecting to the input connector of the spectrum analyzer. Improper connection may damage the spectrum analyzer.

Set as follows in the MU181000A/B operation window:

See Table 6.3.5-1. Operation:

Offset: 0 ppm SSC: ON (Inf Ref) Spread Method: Center

Table 6.3.5-1 Setting for triangular wave modulation measurement

Operation	Division Ratio for Divider
PCIe-GenI (2.5 GHz)	250 divisions
PCIe-GenII (5 GHz)	500 divisions
PCIe-GenIII/IV/V (8 GHz)	800 divisions

Adjust the rising or falling edge of the waveform to the Center of the sampling scope, and set the span to 5 ns/Div. Trace overlapping waveforms for 10 seconds with the oscilloscope, and check that the phase deviation of the measured waveforms falls within the range shown in Figure 6.3.5-2.

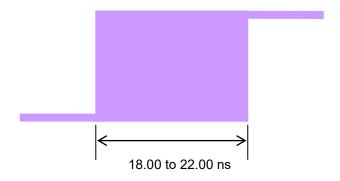


Figure 6.3.5-2 Example of waveform measured by sampling oscilloscope

6.3.6 Measuring trigger output waveform

Measure the trigger output waveform. Connection with the measuring instrument is shown in Figure 6.3.6-1.

MU181000A/B (with MU181000A/B-x01 installed)

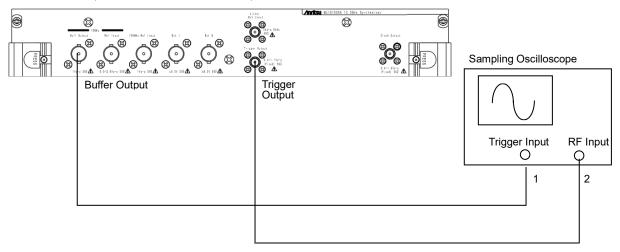


Figure 6.3.6-1 Connection diagram for trigger output waveform measurement

- 1. Connect the Buff Output signal to the Trigger Input connector of the sampling oscilloscope.
- 2. Connect the Trigger Output signal to the RF Input connector of the sampling oscilloscope.



Use an appropriate attenuator for each input connector when connecting to the input connector of the spectrum analyzer. Improper connection may damage the spectrum analyzer.

3. Set as follows in the MU181000A/B operation window:

Operation: Variable

Center Frequency: See Table 6.3.6-1.

Offset: 0 ppm Reference Clock Source: Internal

Trigger Source: See Table 6.3.6-1.

Table 6.3.6-1 Setting for trigger output waveform measurement

Center Frequency	Trigger Source
12500 MHz	F/1
10000 MHz	F/1
6410 MHz	F/1
12500 MHz	F/64
10000 MHz	F/64
6400 MHz	F/64
3200 MHz	F/64
1600 MHz	F/64
810 MHz	F/64

4. Use the averaging function of the sampling oscilloscope to measure the waveform, and then check that the level of the measured waveform falls within the range shown Figure 6.3.6-2.

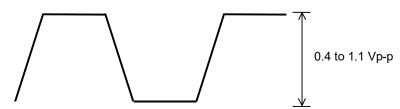


Figure 6.3.6-2 Example of waveform measured by sampling oscilloscope

7

Chapter 7 Maintenance

This section describes maintenance of the MU181000A/B.

7.1	Daily Maintenance	7-2
7.2	Cautions on Storage	7-2
7.3	Transportation	7-3
7.4	Calibration	7-3
7.5	Disposal	7-4

7.1 Daily Maintenance

- Wipe off any external stains with a cloth damped with diluted mild detergent.
- · Vacuum away any accumulated dust or dirt with a vacuum cleaner.
- Tighten any loose parts fixed with screws, using the specified tools.

7.2 Cautions on Storage

Wipe off any dust, soil, or stain on the MU181000A/B prior to storage. Avoid storing the MU181000A/B in any of the following locations:

- Where there is direct sunlight
- Where there is dust
- · Where humidity is high and dew may accumulate
- · Where chemically active gases are present
- Where the MU181000A/B may become oxidized
- · Where strong vibrations are present
- Under the following temperature and humidity conditions: Temperature range of \leq -20°C or \geq 60°C Humidity range of \geq 85%

Recommended storage conditions

In addition to the abovementioned storage cautions, the following environment conditions are recommended for long-term storage.

- Temperature range of 5 to 30°C
- Humidity range of 40 to 75%
- Slight daily fluctuation in temperature and humidity

7.3 Transportation

Use the original packing materials, if possible, when packing the MU181000A/B for transport. If you do not have the original packing materials, pack the MU181000A/B according to the following procedure. When handling the MU181000A/B, always wear clean gloves, and handle it gently so as not to damage it.

<Procedure>

- 1. Use a dry cloth to wipe off any stain or dust on the exterior of the MU181000A/B.
- 2. Check for loose or missing screws.
- 3. Provide protection for structural protrusions and parts that can easily be deformed, and wrap the MU181000A/B with a sheet of polyethylene. Finally, cover with moisture-proof paper.
- 4. Place the wrapped MU181000A/B into a cardboard box, and tape the flaps with adhesive tape. Furthermore, store it in a wooden box as required by the transportation distance or method.
- 5. During transportation, place it under an environment that meets the conditions described in 7.2 "Cautions on Storage".

7.4 Calibration

Regular maintenance such as periodic inspections and calibration is essential for the Signal Quality Analyzer Series for long-term stable performance. Regular inspection and calibration are recommended for using the Signal Quality Analyzer Series in its prime condition at all times. The recommended calibration cycle after delivery of the Signal Quality Analyzer Series is twelve months.

If you require support after delivery, contact an Anritsu Service and Sales office. Contact information can be found on the last page of the printed version of this manual, and is available in a separate file on the CD version.

We may not provide calibration or repair if any of the following cases apply.

- Seven or more years have elapsed after production and parts for the instrument are difficult to obtain, or it is determined that reliability cannot be maintained after calibration/repair due to significant wear.
- Circuit changes, repair, or modifications are done without our approval.
- It is determined that the repair cost would be higher than the price of a new item.

7.5 Disposal

Confirm the notes described in the Signal Quality Analyzer Series Installation Guide and observe national and local regulations when disposing of the MU181000A/B.

Chapter 8 Troubleshooting

This section describes how to check whether a failure has arisen when an error occurs during the operation of the MU181000A/B.

- 8.1 Problems Discovered during Module Replacement 8-2
- 8.2 Problems Discovered during Use of MU181000A/B..... 8-2

8.1 Problems Discovered during Module Replacement

Table 8.1-1 Remedies for problems discovered during replacement of MU181000A/B

Symptom	Location to Check	Remedy
A module is not recognized.	Is the module installed properly?	Install the module again by referring to 2.3 "Installing and Removing Modules" in the installation guide.
	Is the module supported by the main frame?	Check the supported modules and the software version of The MU181000A/B at our Web site (https://www.anritsu.com/en-us/test-measurement/products/mp1800a). If the module is supported, it may have failed. Contact an Anritsu Service and Sales office. Contact information can be found on the last page of the printed version of this manual, and is available in a separate file on the PDF version.

8.2 Problems Discovered during Use of MU181000A/B

Table 8.2-1 Remedies for problems discovered during use of MU181000A/B

Symptom	Location to Check	Remedy
Output waveform is	Is the cable loose?	Tighten the connector.
defective	Do the cables used have good high-frequency characteristics?	Use cables and connectors with good high-frequency characteristics.
	Is the input clock signal used within the specification range?	Connect a signal that meets the input specifications for Clock Input.
	Is the measurement system for waveforms set as shown in 6.3 "Performance Test Item?"	Check the performance test procedure again.

If a problem cannot be solved using any of the items listed above, perform initialization and check the items again. If the problem still occurs, contact an Anritsu Service and Sales office. Contact information can be found on the last page of the printed version of this manual, and is available in a separate file on the PDF version.

Appendix A Performance Test Result Sheet

A.1	Perfor	mance Test Result Sheet	A-2
	A.1.1	Performance Test Result Sheet for	
		MU181000A	A-2
	A.1.2	Performance Test Result Sheet for	
		MU181000B	A-9

A.1 Performance Test Result Sheet

A.1.1 Performance Test Result Sheet for MU181000A

Device name:	MU181000A 12.5GHz Synthesizer
Serial No.:	
Ambient temperature:	<u>°C</u>
Relative humidity:	<u>%</u>

Table A.1.1-1 Results of waveform measurement at Clock Output

Frequency [MHz]	Specifications	Measured Results
12500	0.632 to 2.0 Vp-p	
10000		
5000		
1000		
100		

Table A.1.1-2 Results of phase noise measurement at Clock Output

Frequency [MHz]	Specifications	Measured Results		
r requeries [initiz]	opecinications -	1 kHz Offset	10 kHz Offset	100 kHz Offset
12500	≤–61 dBc/Hz at 1 kHz offset			
10000	≤–80 dBc/Hz at 10 kHz offset			
5000	≤–90 dBc/Hz at 100 kHz offset			
1000				
100				

Devic	e name:	MU181000A 12.5GHz Synthesizer (with MU181000A-x01 installed)
Seria	l No.:	
Ambi	ent temperature:	<u>°C</u>
Relat	ive humidity:	<u>%</u>

Table A.1.1-3 Results of waveform measurement at Clock Output

Frequency [MHz]	Specifications	Measured Results
12500	0.4 to 1 Vp-p	
10000		
5000		
1000		
100		

Table A.1.1-4 Results of phase noise measurement at Clock Output

Frequency [MHz]	Specifications	Measured Results			
i requericy [wiriz]		1 kHz Offset	10 kHz Offset	100 kHz Offset	
12500	≤–61 dBc/Hz at 1 kHz offset				
10000	≤–80 dBc/Hz at 10 kHz offset				
5000	≤–90 dBc/Hz at 100 kHz offset				
1000					
100					

Table A.1.1-5 Results of internal jitter accuracy measurement

Output Frequency [MHz]	Modulation Frequency [kHz]	Jitter Amplitude [Ulp-p]	Specifications	Measured Results
12500	0.009	4000	3718 to 4282 UIp-p	
	0.22	4000	3718 to 4282 UIp-p	
	1	880	816.4 to 943.6 UIp-p	
	10	88	79.84 to 96.16 UIp-p	
	100	8.8	79.84 to 96.16 UIp-p	
	1000	0.88	0.754 to 1.006 UIp-p	
	4000	0.22	0.167 to 0.273 UIp-p	
	10000	0.22	0.167 to 0.273 UIp-p	
	20000	0.22	0.167 to 0.273 UIp-p	
	50000	0.22	0.167 to 0.273 UIp-p	
	80000	0.22	0.167 to 0.273 UIp-p	
9953.28	0.01	22	18.46 to 25.54 UIp-p	
	40	22	18.46 to 25.54 UIp-p	
	4000	0.22	0.167 to 0.273 UIp-p	
	10000	0.22	0.167 to 0.273 UIp-p	
	80000	0.22	0.167 to 0.273 UIp-p	
6400	0.09	4000	3718 to 4282 UIp-p	
	0.11	4000	3718 to 4282 UIp-p	
	1	440	407.2 to 472.8 UIp-p	
	10	44	38.92 to 40.08 UIp-p	
	100	4.4	389.2 to 400.8 UIp-p	
	1000	0.44	0.367 to 0.513 UIp-p	
	2000	0.22	0.174 to 0.266 UIp-p	
	5000	0.22	0.167 to 0.273 UIp-p	
	10000	0.22	0.167 to 0.273 UIp-p	
	20000	0.22	0.167 to 0.273 UIp-p	
	40000	0.22	0.167 to 0.273 UIp-p	
3200	0.009	4000	3718 to 4282 UIp-p	
	0.055	4000	3718 to 4282 UIp-p	
	0.1	2200	2044 to 2356 UIp-p	
	1	220	202.6 to 4282 UIp-p	
	10	22	18.46 to 25.54 UIp-p	
	100	2.2	1.846 to 2.554 UIp-p	
	1000	0.22	0.174 to 0.266 UIp-p	
	5000	0.22	0.167 to 0.273 UIp-p	
	10000	0.22	0.167 to 0.273 UIp-p	

Table A.1.1-5 Results of internal jitter accuracy measurement (Cont'd)

Output Frequency [MHz]	Modulation Frequency [kHz]	Jitter Amplitude [Ulp-p]	Specifications	Measured Results
2488.32	0.01	22	20.26 to 23.74 UIp-p	
	10	22	20.26 to 23.74 UIp-p	
	1000	0.22	0.174 to 0.266 UIp-p	
	10000	0.22	0.167 to 0.273 UIp-p	
	20000	0.22	0.167 to 0.273 UIp-p	
1600	0.009	4000	3718 to 4282 UIp-p	
	0.0275	4000	3718 to 4282 UIp-p	
	0.1	1100	1021 to 1179 UIp-p	
	1	110	100.3 to 119.7 UIp-p	
	10	11	10.03 to 11.97 UIp-p	
	100	1.1	1.003 to 1.197 UIp-p	
	500	0.22	0.185 to 0.255 UIp-p	
	1000	0.22	0.167 to 0.273 UIp-p	
	2000	0.22	0.167 to 0.273 UIp-p	
	5000	0.22	0.167 to 0.273 UIp-p	
	10000	0.22	0.167 to 0.273 UIp-p	
1244.16	0.01	22	18.46 to 25.54 UIp-p	
	5	22	18.46 to 25.54 UIp-p	
	500	0.22	0.185 to 0.255 UIp-p	
	10000	0.22	0.167 to 0.273 UIp-p	
800	0.009	4000	3718 to 4282 UIp-p	
	0.01375	4000	3718 to 4282 UIp-p	
	0.1	550	509.5 to 590.5 UIp-p	
	1	55	49.15 to 60.85 UIp-p	
	10	5.5	4.915 to 6.085 UIp-p	
	100	0.55	0.502 to 0.599 UIp-p	
	250	0.22	0.195 to 0.245 UIp-p	
	1000	0.22	0.184 to 0.256 UIp-p	
	2000	0.22	0.184 to 0.256 UIp-p	
	5000	0.22	0.177 to 0.263 UIp-p	
622.08	0.01	22	18.46 to 25.54 UIp-p	
	2.5	22	18.46 to 25.54 UIp-p	
	250	0.22	0.195 to 0.245 UIp-p	
	5000	0.22	0.177 to 0.263 UIp-p	

Table A.1.1-5 Results of internal jitter accuracy measurement (Cont'd)

Output Frequency [MHz]	Modulation Frequency [kHz]	Jitter Amplitude [Ulp-p]	Specifications	Measured Results
155.52	0.01	22	18.46 to 25.54 UIp-p	
	2.5	22	18.46 to 25.54 UIp-p	
	250	0.22	0.195 to 0.245 UIp-p	
	5000	0.22	0.177 to 0.263 UIp-p	
100	0.01	22	18.46 to 25.54 UIp-p	
	0.2	22	18.46 to 25.54 UIp-p	
	20	0.22	0.195 to 0.245 UIp-p	
	1000	0.22	0.184 to 0.256 UIp-p	
	5000	0.22	0.177 to 0.263 UIp-p	

Table A.1.1-6 Results of external jitter accuracy measurement

Output Frequency [MHz]	Frequency Range	Amplitude Range	Input Frequency	Specifications	Measured Results
12500	$4.4~\mathrm{kHz}$	4000 UI	$220~\mathrm{Hz}$	1000 UIp-p±300 UI	
	$44~\mathrm{kHz}$	200 UI	$4.4~\mathrm{kHz}$	100 UIp-p±30 UI	
	$440~\mathrm{kHz}$	20 UI	44 kHz	10 UIp-p±3 UI	
	$4~\mathrm{MHz}$	2 UI	$440~\mathrm{kHz}$	1 UIp-p±0.3 UI	
	$4~\mathrm{MHz}$	0.22 UI	4 MHz	0.1 UIp-p±0.02 UI	
	80 MHz	0.22 UI	80 MHz	0.1 UIp-p±0.02 UI	
	$500~\mathrm{MHz}$	0.22 UI	$500~\mathrm{MHz}$	0.1 UIp-p±0.02 UI	
	$1~\mathrm{GHz}$	0.22 UI	1 GHz	0.1 UIp-p±0.02 UI	
6400	$2.2~\mathrm{kHz}$	4000 UI	110 Hz	1000 UIp-p±300 UI	
	$22~\mathrm{kHz}$	200 UI	$2.2~\mathrm{kHz}$	100 UIp-p±30 UI	
	$220~\mathrm{kHz}$	20 UI	$22~\mathrm{kHz}$	10 UIp-p±3 UI	
	$2~\mathrm{MHz}$	2 UI	$220~\mathrm{kHz}$	1 UIp-p±0.3 UI	
	$4~\mathrm{MHz}$	0.22 UI	4 MHz	0.1 UIp-p±0.02 UI	
	$80~\mathrm{MHz}$	0.22 UI	80 MHz	0.1 UIp-p±0.02 UI	
	$500~\mathrm{MHz}$	0.22 UI	$500~\mathrm{MHz}$	0.1 UIp-p±0.02 UI	
	1 GHz	0.22 UI	1 GHz	0.1 UIp-p±0.02 UI	
3200	$1.1~\mathrm{kHz}$	4000 UI	55 Hz	1000 UIp-p±300 UI	
	11 kHz	200 UI	1.1 kHz	100 UIp-p±30 UI	

Table A.1.1-6 Results of external jitter accuracy measurement (Cont'd)

Output Frequency [MHz]	Frequency Range	Amplitude Range	Input Frequency	Specifications	Measured Results
3200	$110~\mathrm{kHz}$	20 UI	11 kHz	10 UIp-p±3 UI	
	$1~\mathrm{MHz}$	2 UI	110 kHz	1 UIp-p±0.3 UI	
	$4~\mathrm{MHz}$	0.22 UI	4 MHz	0.1 UIp-p±0.02 UI	
	$80~\mathrm{MHz}$	0.22 UI	80 MHz	0.1 UIp-p±0.02 UI	
	$500~\mathrm{MHz}$	0.22 UI	500 MHz	0.1 UIp-p±0.02 UI	
1600	$550~\mathrm{Hz}$	4000 UI	27.5 Hz	1000 UIp-p±300 UI	
	$5.5~\mathrm{kHz}$	200 UI	550 Hz	100 UIp-p±30 UI	
	$55~\mathrm{kHz}$	20 UI	$5.5~\mathrm{kHz}$	10 UIp-p±3 UI	
	$500~\mathrm{kHz}$	2 UI	$55~\mathrm{kHz}$	1 UIp-p±0.3 UI	
	4 MHz	0.22 UI	4 MHz	0.1 UIp-p±0.02 UI	
	$80~\mathrm{MHz}$	0.22 UI	80 MHz	0.1 UIp-p±0.02 UI	
	$500~\mathrm{MHz}$	0.22 UI	100 MHz	0.1 UIp-p±0.02 UI	
800	$275~\mathrm{Hz}$	4000 UI	$13.75~\mathrm{Hz}$	1000 UIp-p±300 UI	
	$2.75~\mathrm{kHz}$	200 UI	$275~\mathrm{Hz}$	100 UIp-p±30 UI	
	$27.5~\mathrm{kHz}$	20 UI	$2.75~\mathrm{kHz}$	10 UIp-p±3 UI	
	$250~\mathrm{kHz}$	2 UI	$27.5~\mathrm{Hz}$	1 UIp-p±0.3 UI	
	$4~\mathrm{MHz}$	0.22 UI	4 MHz	0.1 UIp-p±0.02 UI	
	$80~\mathrm{MHz}$	0.22 UI	20 MHz	0.1 UIp-p±0.02 UI	
100	$275~\mathrm{Hz}$	4000 UI	13.75 Hz	1000 UIp-p±300 UI	
	$2.75~\mathrm{kHz}$	200 UI	275 Hz	100 UIp-p±30 UI	
	$27.5~\mathrm{kHz}$	20 UI	$2.75~\mathrm{kHz}$	10 UIp-p±3 UI	
	$250~\mathrm{kHz}$	2 UI	27.5 Hz	1 UIp-p±0.3 UI	
	4 MHz	0.22 UI	4 MHz	0.1 UIp-p±0.02 UI	
	$80~\mathrm{MHz}$	0.22 UI	$5~\mathrm{MHz}$	0.1 UIp-p±0.02 UI	

Table A.1.1-7 Results of phase deviation measurement of triangular wave modulation

Output Frequency [MHz]	Specifications	Measured Results
5000	18.00 to 22.00 ns	
2500	18.00 to 22.00 ns	

Table A.1.1-8 Results of trigger output waveform measurement

Output Frequency [MHz]	Trigger Source	Specifications	Measured Results
12500	F/1	0.4 to 1.1 Vp-p	
10000	F/1		
6410	F/1		
12500	F/64		
10000	F/64		
6400	F/64		
3200	F/64		
1600	F/64		
810	F/64		

A.1.2 Performance Test Result Sheet for MU181000B

Device name: MU181000B 12.5GHz 4 port Synthesizer

Serial No.:

Ambient temperature: <u>°C</u>

Relative humidity: %

Table A.1.2-1 Results of waveform measurement at Clock Output

Frequency [MHz]	Specifications	Measured Results
12500	0.4 to 1.0 Vp-p	
10000		
5000		
1000		
100		

Table A.1.2-2 Results of phase noise measurement at Clock Output

Frequency [MHz]	Specifications	Measured Results		
i requericy [wriz]		1 kHz Offset	10 kHz Offset	100 kHz Offset
12500	≤–61 dBc/Hz at 1 kHz offset			
10000	≤–80 dBc/Hz at 10 kHz offset			
5000	≤–90 dBc/Hz at 100 kHz offset			
1000				
100				

Device name:	MU181000B 12.5GHz 4 port Synthesizer (with MU181000B-x01 installed)
Serial No.:	
Ambient temperature:	<u>°C</u>
Relative humidity:	<u>%</u>

Table A.1.2-3 Results of waveform measurement at Clock Output

Frequency [MHz]	Specifications	Measured Results
12500	0.4 to 1 Vp-p	
10000		
5000		
1000		
100		

Table A.1.2-4 Results of phase noise measurement at Clock Output

Frequency [MHz]	/ [MHz] Specifications		Measured Results		
r requeries [initiz]	Specifications	1 kHz Offset	10 kHz Offset	100 kHz Offset	
12500	≤–61 dBc/Hz at 1 kHz offset				
10000	≤–80 dBc/Hz at 10 kHz offset				
5000	≤–90 dBc/Hz at 100 kHz offset				
1000					
100					

Table A.1.2-5 Results of internal jitter accuracy measurement

Output Frequency [MHz]	Modulation Frequency [kHz]	Jitter Amplitude [Ulp-p]	Specifications	Measured Results
12500	0.009	4000	3718 to 4282 UIp-p	
	0.22	4000	3718 to 4282 UIp-p	
	1	880	816.4 to 943.6 UIp-p	
	10	88	79.84 to 96.16 UIp-p	
	100	8.8	79.84 to 96.16 UIp-p	
	1000	0.88	0.754 to 1.006 UIp-p	
	4000	0.22	0.167 to 0.273 UIp-p	
	10000	0.22	0.167 to 0.273 UIp-p	
	20000	0.22	0.167 to 0.273 UIp-p	
	50000	0.22	0.167 to 0.273 UIp-p	
	80000	0.22	0.167 to 0.273 UIp-p	
9953.28	0.01	22	18.46 to 25.54 UIp-p	
	40	22	18.46 to 25.54 UIp-p	
	4000	0.22	0.167 to 0.273 UIp-p	
	10000	0.22	0.167 to 0.273 UIp-p	
	80000	0.22	0.167 to 0.273 UIp-p	
6400	0.09	4000	3718 to 4282 UIp-p	
	0.11	4000	3718 to 4282 UIp-p	
	1	440	407.2 to 472.8 UIp-p	
	10	44	38.92 to 40.08 UIp-p	
	100	4.4	389.2 to 400.8 UIp-p	
	1000	0.44	0.367 to 0.513 UIp-p	
	2000	0.22	0.174 to 0.266 UIp-p	
	5000	0.22	0.167 to 0.273 UIp-p	
	10000	0.22	0.167 to 0.273 UIp-p	
	20000	0.22	0.167 to 0.273 UIp-p	
	40000	0.22	0.167 to 0.273 UIp-p	
3200	0.009	4000	3718 to 4282 UIp-p	
	0.055	4000	3718 to 4282 UIp-p	
	0.1	2200	2044 to 2356 UIp-p	
	1	220	202.6 to 4282 UIp-p	
	10	22	18.46 to 25.54 UIp-p	
	100	2.2	1.846 to 2.554 UIp-p	
	1000	0.22	0.174 to 0.266 UIp-p	
	5000	0.22	0.167 to 0.273 UIp-p	
	10000	0.22	0.167 to 0.273 UIp-p	

Table A.1.2-5 Results of internal jitter accuracy measurement (Cont'd)

Output Frequency [MHz]	Modulation Frequency [kHz]	Jitter Amplitude [Ulp-p]	Specifications	Measured Results
2488.32	0.01	22	20.26 to 23.74 UIp-p	
	10	22	20.26 to 23.74 UIp-p	
	1000	0.22	0.174 to 0.266 UIp-p	
	10000	0.22	0.167 to 0.273 UIp-p	
	20000	0.22	0.167 to 0.273 UIp-p	
1600	0.009	4000	3718 to 4282 UIp-p	
	0.0275	4000	3718 to 4282 UIp-p	
	0.1	1100	1021 to 1179 UIp-p	
	1	110	100.3 to 119.7 UIp-p	
	10	11	10.03 to 11.97 UIp-p	
	100	1.1	1.003 to 1.197 UIp-p	
	500	0.22	0.185 to 0.255 UIp-p	
	1000	0.22	0.167 to 0.273 UIp-p	
	2000	0.22	0.167 to 0.273 UIp-p	
	5000	0.22	0.167 to 0.273 UIp-p	
	10000	0.22	0.167 to 0.273 UIp-p	
1244.16	0.01	22	18.46 to 25.54 UIp-p	
	5	22	18.46 to 25.54 UIp-p	
	500	0.22	0.185 to 0.255 UIp-p	
	10000	0.22	0.167 to 0.273 UIp-p	
800	0.009	4000	3718 to 4282 UIp-p	
	0.01375	4000	3718 to 4282 UIp-p	
	0.1	550	509.5 to 590.5 UIp-p	
	1	55	49.15 to 60.85 UIp-p	
	10	5.5	4.915 to 6.085 UIp-p	
	100	0.55	0.502 to 0.599 UIp-p	
	250	0.22	0.195 to 0.245 UIp-p	
	1000	0.22	0.184 to 0.256 UIp-p	
	2000	0.22	0.184 to 0.256 UIp-p	
	5000	0.22	0.177 to 0.263 UIp-p	
622.08	0.01	22	18.46 to 25.54 UIp-p	
	2.5	22	18.46 to 25.54 UIp-p	
	250	0.22	0.195 to 0.245 UIp-p	
	5000	0.22	0.177 to 0.263 UIp-p	

Table A.1.2-5 Results of internal jitter accuracy measurement (Cont'd)

Output Frequency [MHz]	Modulation Frequency [kHz]	Jitter Amplitude [Ulp-p]	Specifications	Measured Results
155.52	0.01	22	18.46 to 25.54 UIp-p	
	2.5	22	18.46 to 25.54 UIp-p	
	250	0.22	0.195 to 0.245 UIp-p	
	5000	0.22	0.177 to 0.263 UIp-p	
100	0.01	22	18.46 to 25.54 UIp-p	
	0.2	22	18.46 to 25.54 UIp-p	
	20	0.22	0.195 to 0.245 UIp-p	
	1000	0.22	0.184 to 0.256 UIp-p	
	5000	0.22	0.177 to 0.263 UIp-p	

Table A.1.2-6 Results of external jitter accuracy measurement

Output Frequency [MHz]	Frequency Range	Amplitude Range	Input Frequency	Specifications	Measured Results
12500	$4.4~\mathrm{kHz}$	4000 UI	220 Hz	1000 UIp-p±300 UI	
	$44~\mathrm{kHz}$	200 UI	$4.4~\mathrm{kHz}$	100 UIp-p±30 UI	
	$440~\mathrm{kHz}$	20 UI	44 kHz	10 UIp-p±3 UI	
	$4~\mathrm{MHz}$	2 UI	$440~\mathrm{kHz}$	1 UIp-p±0.3 UI	
	$4~\mathrm{MHz}$	0.22 UI	4 MHz	0.1 UIp-p±0.02 UI	
	$80~\mathrm{MHz}$	0.22 UI	80 MHz	0.1 UIp-p±0.02 UI	
	$500~\mathrm{MHz}$	0.22 UI	500 MHz	0.1 UIp-p±0.02 UI	
	1 GHz	0.22 UI	1 GHz	0.1 UIp-p±0.02 UI	
6400	$2.2~\mathrm{kHz}$	4000 UI	110 Hz	1000 UIp-p±300 UI	
	$22~\mathrm{kHz}$	200 UI	$2.2~\mathrm{kHz}$	100 UIp-p±30 UI	
	$220~\mathrm{kHz}$	20 UI	$22~\mathrm{kHz}$	10 UIp-p±3 UI	
	$2~\mathrm{MHz}$	2 UI	$220~\mathrm{kHz}$	1 UIp-p±0.3 UI	
	$4~\mathrm{MHz}$	0.22 UI	4 MHz	0.1 UIp-p±0.02 UI	
	80 MHz	0.22 UI	80 MHz	0.1 UIp-p±0.02 UI	
	500 MHz	0.22 UI	500 MHz	0.1 UIp-p±0.02 UI	
	1 GHz	0.22 UI	1 GHz	0.1 UIp-p±0.02 UI	
3200	1.1 kHz	4000 UI	55 Hz	1000 UIp-p±300 UI	
	11 kHz	200 UI	1.1 kHz	100 UIp-p±30 UI	

Table A.1.2-6 Results of external jitter accuracy measurement (Cont'd)

Output Frequency [MHz]	Frequency Range	Amplitude Range	Input Frequency	Specifications	Measured Results
3200	$110~\mathrm{kHz}$	20 UI	11 kHz	10 UIp-p±3 UI	
	$1~\mathrm{MHz}$	2 UI	110 kHz	1 UIp-p±0.3 UI	
	$4~\mathrm{MHz}$	0.22 UI	4 MHz	0.1 UIp-p±0.02 UI	
	$80~\mathrm{MHz}$	0.22 UI	80 MHz	0.1 UIp-p±0.02 UI	
	$500~\mathrm{MHz}$	0.22 UI	500 MHz	0.1 UIp-p±0.02 UI	
1600	$550~\mathrm{Hz}$	4000 UI	27.5 Hz	1000 UIp-p±300 UI	
	$5.5~\mathrm{kHz}$	200 UI	550 Hz	100 UIp-p±30 UI	
	$55~\mathrm{kHz}$	20 UI	$5.5~\mathrm{kHz}$	10 UIp-p±3 UI	
	$500~\mathrm{kHz}$	2 UI	$55~\mathrm{kHz}$	1 UIp-p±0.3 UI	
	4 MHz	0.22 UI	4 MHz	0.1 UIp-p±0.02 UI	
	80 MHz	0.22 UI	80 MHz	0.1 UIp-p±0.02 UI	
	500 MHz	0.22 UI	100 MHz	0.1 UIp-p±0.02 UI	
800	275 Hz	4000 UI	13.75 Hz	1000 UIp-p±300 UI	
	$2.75~\mathrm{kHz}$	200 UI	275 Hz	100 UIp-p±30 UI	
	$27.5~\mathrm{kHz}$	20 UI	$2.75~\mathrm{kHz}$	10 UIp-p±3 UI	
	$250~\mathrm{kHz}$	2 UI	27.5 Hz	1 UIp-p±0.3 UI	
	4 MHz	0.22 UI	4 MHz	0.1 UIp-p±0.02 UI	
	80 MHz	0.22 UI	20 MHz	0.1 UIp-p±0.02 UI	
100	275 Hz	4000 UI	13.75 Hz	1000 UIp-p±300 UI	
	$2.75~\mathrm{kHz}$	200 UI	275 Hz	100 UIp-p±30 UI	
	$27.5~\mathrm{kHz}$	20 UI	$2.75~\mathrm{kHz}$	10 UIp-p±3 UI	
	$250~\mathrm{kHz}$	2 UI	27.5 Hz	1 UIp-p±0.3 UI	
	4 MHz	0.22 UI	4 MHz	0.1 UIp-p±0.02 UI	
	80 MHz	0.22 UI	5 MHz	0.1 UIp-p±0.02 UI	

Table A.1.2-7 Results of phase deviation measurement of triangular wave modulation

Output Frequency [MHz]	Specifications	Measured Results
5000	18.00 to 22.00 ns	
2500	18.00 to 22.00 ns	
8000*	18.00 to 22.00 ns	

^{*:} This test can be performed only when MU181000B-x02 is installed.

Table A.1.2-8 Results of trigger output waveform measurement

Output Frequency [MHz]	Trigger Source	Specifications	Measured Results
12500	F/1	0.4 to 1.1 Vp-p	
10000	F/1		
6410	F/1		
12500	F/64		
10000	F/64		
6400	F/64		
3200	F/64		
1600	F/64		
810	F/64		

Appendix B List of Initial Setting Items

B.1 List of Initial Setting Items

Table B.1-1 Initial setting items for MU181000A/B

	Value	
Operation Frequency	Center Frequency	12500 MHz
	Offset	0
Reference Clock	Source	Internal

Table B.1-2 Initial setting items when MU181000A/B-x01 is installed

	Value	
Operation Frequency	Operation	Variable
	Center Frequency	12500 MHz
	Offset	0
Reference Clock	Source	Internal
Spectrum Spread	SSC	Nondisplay
	Spread Method	Nondisplay
Jitter	Jitter	OFF
	Modulation Source	Internal
	Frequency	9.000 Hz
	Amplitude	1.000 UIp-p
	Trigger Source	f/64

Appendix C List of Setting Items in Customize Screen

C.1 List of Setting Items in Customize Screen

Table C.1-1 Setting items in customize screen

ltem				
Operation Frequency	Center Frequency (in the selected units)			
	Offset			